

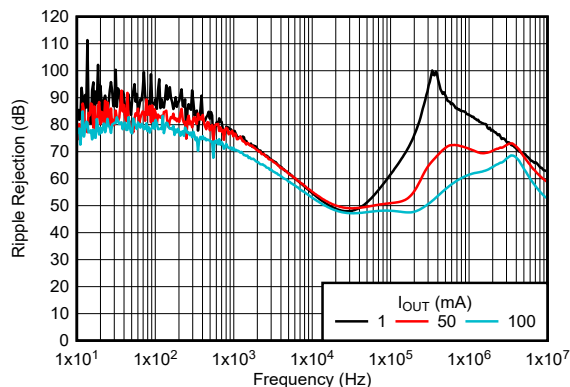
# TPS769-Q1 100mA, 16V, Low-Dropout Linear Regulator

## 1 Features

- AEC-Q100 qualified for automotive applications:
  - Temperature grade 1:  $-40^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ ,  $T_A$
- Input voltage range:
  - Legacy chip: 2.7V to 10V (13.5V absolute max)
  - New chip: 2.5V to 16V (18V absolute max)
- Output voltage range (adjustable):
  - Legacy chip: 1.25V to 5.5V
  - New chip: 1.2V to 5.5V
- Output voltage range (fixed):
  - Legacy chip: 1.5V to 5V
  - New chip: 1.2V to 5V
- High PSRR (new chip): 46dB at 1MHz
- Output accuracy:
  - Legacy chip: 3% over load and temperature
  - New chip: 1.2% over load and temperature
- Dropout voltage:
  - Legacy chip: 71mV (typ) at 100mA
  - New chip: 150mV (typ) at 100mA
- Integrated fault protection:
  - Thermal shutdown
  - Overcurrent protection
- Internal soft-start time (new chip): 750 $\mu\text{s}$  (typical)
- Output capacitor for stable operation:
  - Legacy chip:  $\geq 4.7\mu\text{F}$
  - New chip:  $\geq 2.2\mu\text{F}$
- Package: 5-pin SOT-23,  $R_{\theta\text{JA}} = 178.6^{\circ}\text{C/W}$  (new chip)

## 2 Applications

- [Hybrid, electric, and powertrain systems](#)
- [ADAS modules](#)
- [Infotainment and cluster](#)
- [Industrial transportation](#)



TPS769-Q1 PSRR vs Output Current (New Chip)

## 3 Description

The TPS769-Q1 is a low-dropout (LDO) linear voltage regulator. This device supports an input voltage range from 2.5V to 16V (new chip) and up to 100mA of load current. For the new chip, the supported output range is from 1.2V to 5.0V (fixed version) or from 1.2V to 5.5V (adjustable version).

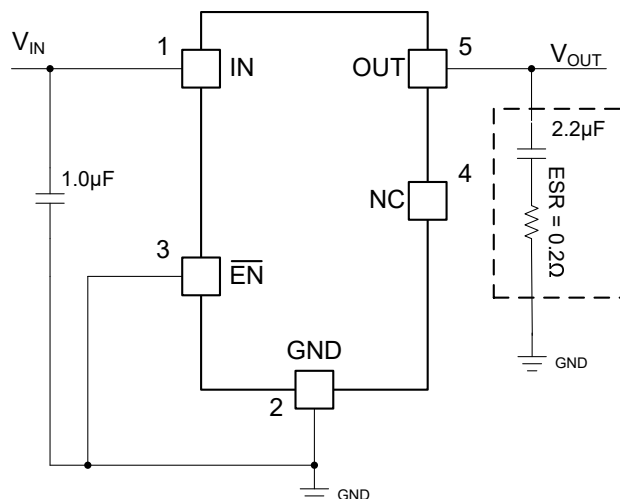
The wide input voltage range makes the device a good choice for operating from regulated rails (such as 10V or 12V). The voltage range is up to 16V for the new chip. This range allows the LDO to generate the bias voltage for a variety of applications. These applications include power microcontrollers (MCUs) and processors, as well as silicon carbide (SiC) gate drivers and microphones.

Wide bandwidth PSRR performance is greater than 70dB at 1kHz and 46dB at 1MHz (new chip). This performance helps attenuate the switching frequency of an upstream DC/DC converter and minimizes post regulator filtering. The new chip supports an internal soft-start circuit mechanism that reduces inrush current during start-up, thus allowing for smaller input capacitance.

### Package Information

PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE <sup>(2)</sup>
TPS769-Q1	DBV (SOT-23, 5)	2.9mm × 2.8mm

- (1) For more information, see the [Mechanical, Packaging, and Orderable Information](#).
- (2) The package size (length × width) is a nominal value and includes pins, where applicable.



Typical Application Circuit



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## 4 Pin Configuration and Functions

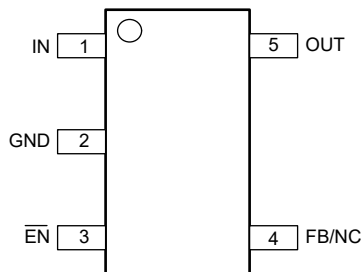


Figure 4-1. DBV Package, 5-Pin SOT-23 (Top View)

Table 4-1. Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	IN	I	Input pin. Use the recommended capacitor value as listed in the <a href="#">Recommended Operating Conditions</a> . Place the input capacitor as close to the IN and GND pins of the device as possible. See the <a href="#">Input and Output Capacitor Requirements</a> section for more information.
2	GND	—	Ground.
3	EN	I	Enable pin. Driving the enable pin low enables the device. Driving this pin high disables the device. Low and high thresholds are listed in the <a href="#">Electrical Characteristics</a> table.
4	FB/NC	I	Adjustable version (TPS76901-Q1): Feedback pin. Input to the control-loop error amplifier. This pin sets the output voltage of the device with external resistors. Do not float this pin. Fixed version: No connection (legacy chip). Do not connect (new chip).
5	OUT	O	Output pin. Use the recommended capacitor value as listed in the <a href="#">Recommended Operating Conditions</a> . Place the output capacitor as close to the OUT and GND pins of the device as possible. See the <a href="#">Input and Output Capacitor Requirements</a> section for more information.

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup> <sup>(2)</sup>

		MIN	MAX	UNIT	
V <sub>IN</sub>	Continuous input voltage (legacy chip)	-0.3	13.5	V	
	Continuous input voltage (new chip)	-0.3	18		
V <sub>OUT</sub>	Output voltage (legacy chip)	-0.3	7		
	Output voltage (new chip)	-0.3	V <sub>IN</sub> + 0.3 or 7 (whichever is smaller)		
V <sub>FB</sub>	FB pin voltage (legacy chip)	-0.3	7		
	FB pin voltage (new chip)	-0.3	3		
V <sub>EN</sub>	EN pin voltage (legacy chip)	-0.3	V <sub>IN</sub> + 0.3		
	EN pin voltage (new chip)	-0.3	18		
Current	Maximum output	Internally limited			A
Temperature	Operating junction temperature, T <sub>J</sub> (legacy chip)	-40	150		°C
	Operating junction temperature, T <sub>J</sub> (new chip)	-55	150		
	Storage, T <sub>stg</sub>	-65	150		

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages with respect to GND.

### 5.2 ESD Ratings

			VALUE (Legacy Chip)	VALUE (New Chip)	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	±3000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	N/A	±1000	

- (1) JEDEC document JEP155 states that 2kV HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 500V CDM allows safe manufacturing with a standard ESD control process.

### 5.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V <sub>IN</sub>	Supply input voltage (legacy chip)	2.7		10	V
	Supply input voltage (new chip)	2.5		16	
V <sub>OUT</sub>	Output voltage (legacy chip)	1.25		5.5	V
	Output voltage (new chip)	1.2		5.5	
V <sub>FB</sub>	FB voltage (legacy chip)		1.224		V
	FB voltage (new chip)		1.2		
V <sub>EN</sub>	Enable voltage (legacy chip)	0		V <sub>IN</sub>	V
	Enable voltage (new chip)	0		16	
I <sub>OUT</sub>	Output current	0		100	mA
C <sub>IN</sub> <sup>(1)</sup>	Input capacitor		1		μF
C <sub>OUT</sub> <sup>(1)</sup>	Output capacitor (legacy chip)	4.7			μF
	Output capacitor (new chip)	2.2		200	
ESR	ESR range (legacy chip)	0.2		10	Ω
	ESR range (new chip)	0		3	
T <sub>J</sub>	Operating junction temperature	-40		125	°C

- (1) All capacitor values are assumed to derate to 50% of the nominal capacitor value. Maintain an effective output capacitance of 1 μF minimum for stability.

### 5.4 Thermal Information

THERMAL METRIC (TPS769-Q1) <sup>(1)</sup> <sup>(2)</sup>		Legacy chip	New chip	UNIT
		DBV (SOT23-5)	DBV (SOT23-5)	
		5 PINS	5 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	204.6	178.6	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	117.5	77.9	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	34.4	47.2	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	11.8	15.9	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	33.5	46.9	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application note.
- (2) Thermal performance results are based on the JEDEC standard of 2s2p PCB configuration. These thermal metric parameters can be further improved by 35-55% based on thermally optimized PCB layout designs. See the analysis of the [Impact of board layout on LDO thermal performance](#) application note.

## 5.5 Dissipation Ratings (Legacy Chip)

DISSIPATION RATINGS			UNIT
THERMAL METRIC	DBV (SOT-23) 5 PINS		
	Low K <sup>(1)</sup>	High K <sup>(2)</sup>	
R <sub>θJC</sub> (Junction-to-case thermal resistance)	65.8	65.8	°C/W
R <sub>θJA</sub> (Junction-to-ambient thermal resistance)	259	180	°C/W
Derating factor above T <sub>A</sub> = +25°C	3.9	5.6	mW/°C
Power rating (T <sub>A</sub> < 25°C)	386	555	mW
Power rating (T <sub>A</sub> = 70°C)	212	305	mW
Power rating (T <sub>A</sub> = 85°C)	154	222	mW

- (1) The JEDEC Low K (1s) board design used to derive this data was a 3 inch x 3 inch, two layer board with 2 ounce copper traces on top of the board.
- (2) The JEDEC High K (2s2p) board design used to derive this data was a 3 inch x 3 inch, multilayer board with 1 ounce internal power and ground planes and 2 ounce copper traces on top and bottom of the board.

## 5.6 Electrical Characteristics

specified at T<sub>J</sub> = –40°C to 125°C, V<sub>IN</sub> = V<sub>OUT(nom)</sub> + 1.0V or V<sub>IN</sub> = 2.5V (whichever is greater), I<sub>OUT</sub> = 10μA,  $\overline{EN}$  = 0V, C<sub>IN</sub> = 1.0μF, C<sub>OUT</sub> = 2.2μF (unless otherwise noted); typical values are at T<sub>J</sub> = 25°C

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
V <sub>OUT</sub>	Output voltage	Adjustable, legacy chip	1.2V ≤ V <sub>OUT</sub> ≤ 5.5V, 10μA ≤ I <sub>OUT</sub> ≤ 100mA, T <sub>J</sub> = 25°C	V <sub>OUT</sub>			V
			1.2V ≤ V <sub>OUT</sub> ≤ 5.5V, 10μA ≤ I <sub>OUT</sub> ≤ 100mA	0.97 × V <sub>OUT</sub>	1.03 × V <sub>OUT</sub>		
		Fixed, legacy chip	10μA ≤ I <sub>OUT</sub> ≤ 100mA, T <sub>J</sub> = 25°C, V <sub>OUT(nom)</sub> + 1V < V <sub>IN</sub> < 10V	V <sub>OUT</sub>			
			10μA ≤ I <sub>OUT</sub> ≤ 100mA, V <sub>OUT(nom)</sub> + 1V < V <sub>IN</sub> < 10V	0.97 × V <sub>OUT</sub>	1.03 × V <sub>OUT</sub>		
New chip	10μA ≤ I <sub>OUT</sub> ≤ 100mA, V <sub>OUT(nom)</sub> + 1V < V <sub>IN</sub> < 16V	0.988 × V <sub>OUT</sub>	1.012 × V <sub>OUT</sub>				
V <sub>FB</sub>	Feedback voltage	Legacy chip		1.224			V
		New chip		1.2			
I <sub>Q</sub>	Quiescent current (GND current)	Legacy chip	EN = 0V, 0mA ≤ I <sub>OUT</sub> ≤ 100mA, T <sub>J</sub> = +25°C	17			μA
			EN = 0V, I <sub>OUT</sub> = 100mA		28		
		New chip	EN = 0V, I <sub>OUT</sub> = 0mA (adjustable)	50	80		
			EN = 0V, I <sub>OUT</sub> = 0mA (fixed)	55	95		
EN = 0V, I <sub>OUT</sub> = 100mA	620						
ΔV <sub>OUT(ΔV<sub>OUT</sub>)</sub>	Output voltage line regulation (ΔV <sub>OUT</sub> /V <sub>OUT</sub> )	Legacy chip	V <sub>OUT(NOM)</sub> + 1.0V ≤ V <sub>IN</sub> ≤ 10V, I <sub>OUT</sub> = 100mA, T <sub>J</sub> = 25°C	0.04			%V
		New chip	V <sub>OUT(NOM)</sub> + 1.0V ≤ V <sub>IN</sub> ≤ 16V, I <sub>OUT</sub> = 10μA	0.032			
ΔV <sub>OUT(ΔI<sub>OUT</sub>)</sub>	Output voltage load regulation	Legacy chip	0mA ≤ I <sub>OUT</sub> ≤ 100mA, T <sub>J</sub> = 25°C	12			mV
		New chip	0mA ≤ I <sub>OUT</sub> ≤ 100mA, T <sub>J</sub> = 25°C	20			
V <sub>n</sub>	Output noise voltage	Legacy chip	BW = 300Hz to 50kHz, C <sub>OUT</sub> = 10μF, T <sub>J</sub> = 25°C	190			μV <sub>RMS</sub>
		New chip	BW = 300Hz to 50kHz, I <sub>OUT</sub> = 100mA, C <sub>OUT</sub> = 4.7μF	165			
			BW = 10Hz to 100kHz, I <sub>OUT</sub> = 100mA, C <sub>OUT</sub> = 4.7μF	195			

## 5.6 Electrical Characteristics (continued)

specified at  $T_J = -40^\circ\text{C}$  to  $125^\circ\text{C}$ ,  $V_{IN} = V_{OUT(nom)} + 1.0\text{V}$  or  $V_{IN} = 2.5\text{V}$  (whichever is greater),  $I_{OUT} = 10\mu\text{A}$ ,  $\overline{\text{EN}} = 0\text{V}$ ,  $C_{IN} = 1.0\mu\text{F}$ ,  $C_{OUT} = 2.2\mu\text{F}$  (unless otherwise noted); typical values are at  $T_J = 25^\circ\text{C}$

PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	UNIT
$T_{SD(\text{shutdow}n)}$	Thermal shutdown temperature	New chip	Temperature increasing		173		$^\circ\text{C}$
$T_{SD(\text{reset})}$	Thermal shutdown reset temperature	New chip	Temperature falling		157		$^\circ\text{C}$
$I_{CL}$	Output current limit	Legacy chip	$V_{OUT} = 0\text{V}$		350	750	mA
		New chip			370	450	
$I_{\text{STANDBY}}$	Standby current	Legacy chip	$\overline{\text{EN}} = V_{IN}, 2.7\text{V} < V_{IN} < 10\text{V}$		1		$\mu\text{A}$
			$\overline{\text{EN}} = V_{IN}, 2.7\text{V} < V_{IN} < 10\text{V}$			2	
		New chip	$\overline{\text{EN}} = V_{IN}, 2.5\text{V} < V_{IN} < 16\text{V}$		0.9		
			$\overline{\text{EN}} = V_{IN}, 2.5\text{V} < V_{IN} < 16\text{V}$			2.75	
$I_{FB}$	Feedback pin current	Legacy chip	$V_{FB} = 1.224\text{V}$		-1	1	$\mu\text{A}$
		New chip	$V_{FB} = 1.2\text{V}$		-0.1	0.1	
$\overline{\text{EN}}$	High level enable input voltage	Legacy chip	$2.7\text{V} \leq V_{IN} \leq 10\text{V}$		1.7		V
	Low level enable input voltage					0.9	
	High level enable input voltage	New chip	$2.5\text{V} \leq V_{IN} \leq 16\text{V}$		1.6		
	Low level enable input voltage					0.415	
PSRR	Power-supply ripple rejection	Legacy chip	$I_{OUT} = 100\text{mA}$ , $f = 1\text{kHz}$ , $C_{OUT} = 10\mu\text{F}$ , $T_J = 25^\circ\text{C}$		60		dB
		New chip	$I_{OUT} = 100\text{mA}$ , $f = 1\text{kHz}$ , $C_{OUT} = 4.7\mu\text{F}$ , $T_J = 25^\circ\text{C}$		58		
$I_{EN}$	Input current ( $\overline{\text{EN}}$ )	Legacy chip	$\overline{\text{EN}} = 0\text{V}$	-1	0	1	$\mu\text{A}$
			$\overline{\text{EN}} = V_{IN}$	-1		1	
		New chip	$\overline{\text{EN}} = 0\text{V}$	-0.75	-0.4	0.02	
			$\overline{\text{EN}} = 6\text{V}$	-0.01		0.01	

### 5.6 Electrical Characteristics (continued)

specified at  $T_J = -40^\circ\text{C}$  to  $125^\circ\text{C}$ ,  $V_{IN} = V_{OUT(nom)} + 1.0\text{V}$  or  $V_{IN} = 2.5\text{V}$  (whichever is greater),  $I_{OUT} = 10\mu\text{A}$ ,  $\overline{EN} = 0\text{V}$ ,  $C_{IN} = 1.0\mu\text{F}$ ,  $C_{OUT} = 2.2\mu\text{F}$  (unless otherwise noted); typical values are at  $T_J = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{DO}$	Dropout voltage	TPS76928-Q1 (legacy chip)	$I_{OUT} = 50\text{mA}$		60	mV
			$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		125	
			$I_{OUT} = 100\text{mA}$		122	
			$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		245	
		TPS76928-Q1 (new chip)	$I_{OUT} = 50\text{mA}$		120	
			$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		184	
			$I_{OUT} = 100\text{mA}$		150	
			$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		218	
		TPS76930-Q1 (legacy chip)	$I_{OUT} = 50\text{mA}$		57	
			$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		115	
			$I_{OUT} = 100\text{mA}$		115	
			$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		230	
		TPS76930-Q1 (new chip)	$I_{OUT} = 50\text{mA}$		120	
			$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		184	
			$I_{OUT} = 100\text{mA}$		150	
			$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		218	
		TPS76933-Q1 (legacy chip)	$I_{OUT} = 50\text{mA}$		48	
			$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		100	
			$I_{OUT} = 100\text{mA}$		98	
			$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		200	
		TPS76933-Q1 (new chip)	$I_{OUT} = 50\text{mA}$		120	
			$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		184	
			$I_{OUT} = 100\text{mA}$		150	
			$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		218	
		TPS76950-Q1 (legacy chip)	$I_{OUT} = 50\text{mA}$		35	
			$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		85	
			$I_{OUT} = 100\text{mA}$		71	
			$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		170	
TPS76950-Q1 (new chip)	$I_{OUT} = 50\text{mA}$		120			
	$I_{OUT} = 50\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		184			
	$I_{OUT} = 100\text{mA}$		150			
	$I_{OUT} = 100\text{mA}, T_J = -40^\circ\text{C}$ to $125^\circ\text{C}$		218			
$V_{UVLO+}$	Rising bias supply UVLO	TPS769-Q1 (new chip)	$V_{IN}$ rising, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	2.2	2.4	V
$V_{UVLO-}$	Falling bias supply UVLO		$V_{IN}$ falling, $-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	1.9	2.07	
$V_{UVLO(HYST)}$	UVLO hysteresis		$-40^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$	0.130		

### 5.7 Typical Characteristics

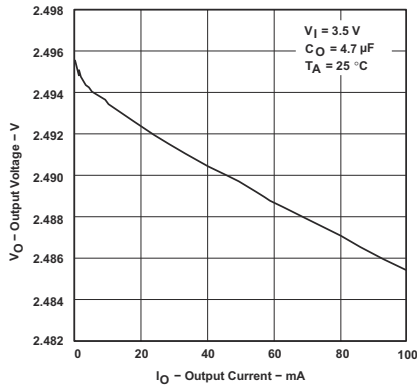


Figure 5-1. TPS76925-Q1 Output Voltage vs Output Current (Legacy Chip)

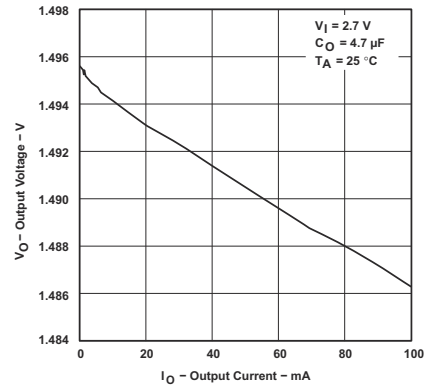


Figure 5-2. TPS76915-Q1 Output Voltage vs Output Current (Legacy Chip)

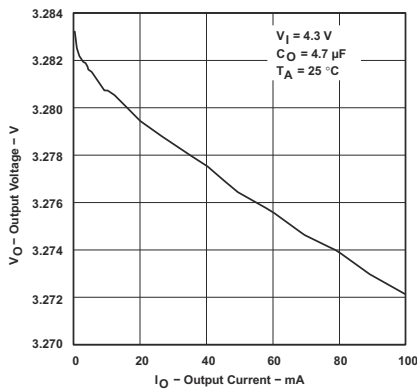


Figure 5-3. TPS76933-Q1 Output Voltage vs Output Current (Legacy Chip)

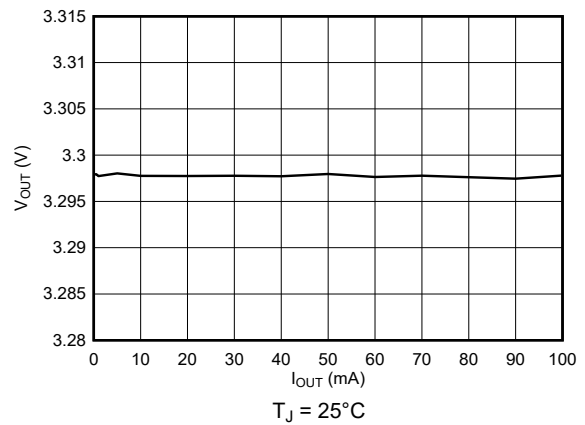


Figure 5-4. TPS76933-Q1 Output Voltage vs Output Current (New Chip)

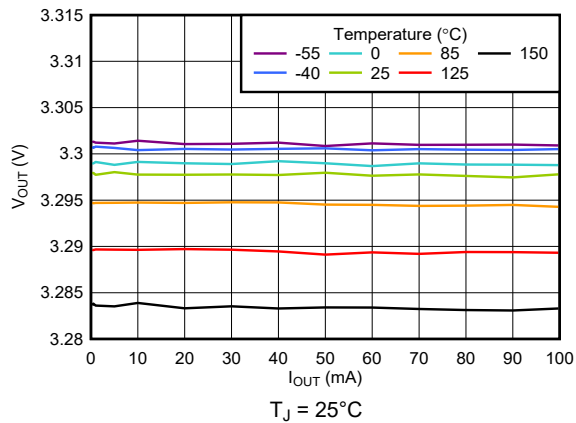


Figure 5-5. TPS76933-Q1 Output Voltage vs Output Current (New Chip)

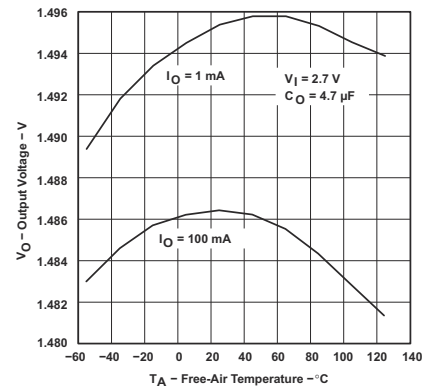
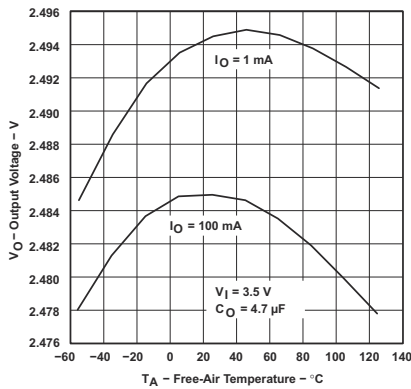


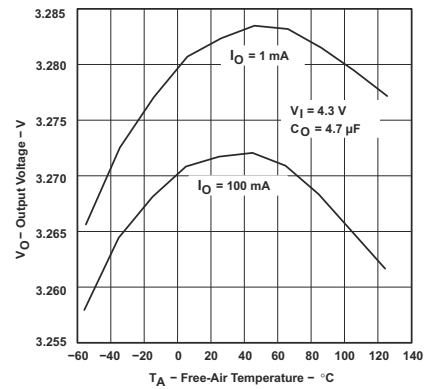
Figure 5-6. TPS76915-Q1 Output Voltage vs Free-Air Temperature (Legacy Chip)



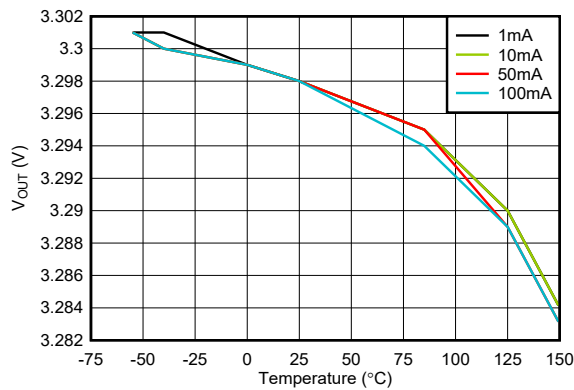
### 5.7 Typical Characteristics (continued)



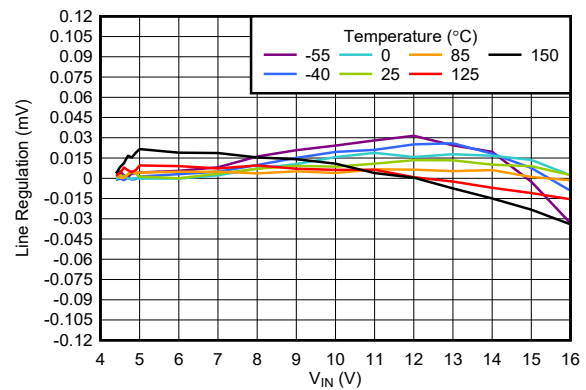
**Figure 5-7. TPS76925-Q1 Output Voltage vs Free-Air Temperature (Legacy Chip)**



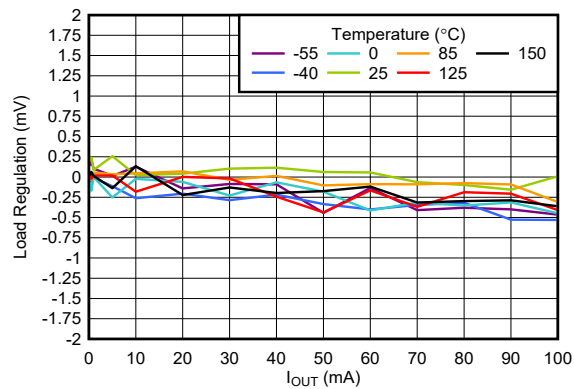
**Figure 5-8. TPS76933-Q1 Output Voltage vs Free-Air Temperature (Legacy Chip)**



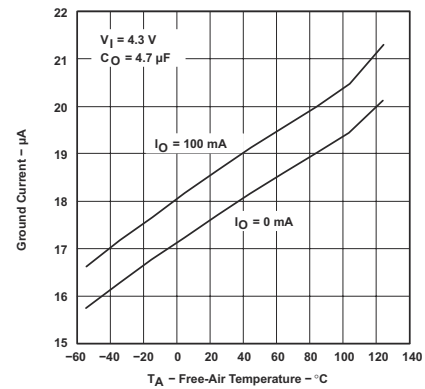
**Figure 5-9. TPS76933-Q1 Output Voltage vs Free-Air Temperature (New Chip)**



**Figure 5-10. TPS76933-Q1 Line Regulation vs Free-Air Temperature (New Chip)**



**Figure 5-11. TPS76933-Q1 Load Regulation vs Free-Air Temperature (New Chip)**



**Figure 5-12. TPS76933-Q1 Ground Current vs Free-Air Temperature (Legacy Chip)**

### 5.7 Typical Characteristics (continued)

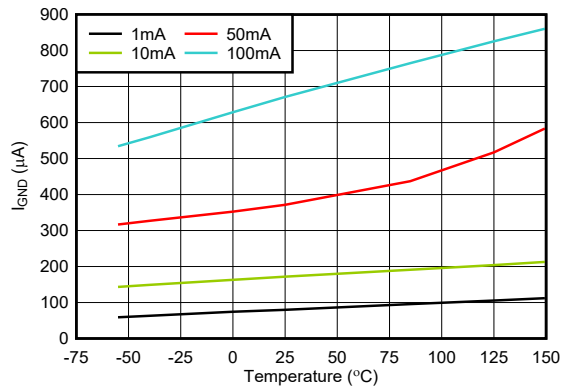


Figure 5-13. TPS76933-Q1 Ground Current vs Free-Air Temperature (New Chip)

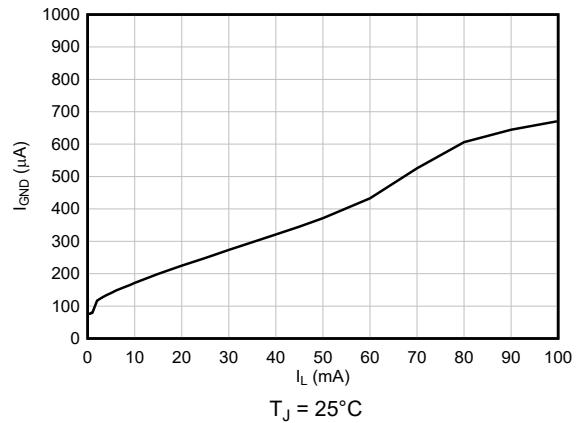


Figure 5-14. TPS76933-Q1 Ground Current vs Output Current (New Chip)

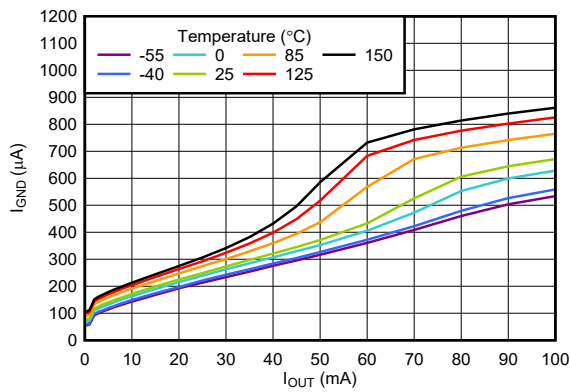


Figure 5-15. TPS76933-Q1 Ground Current vs Output Current (New Chip)

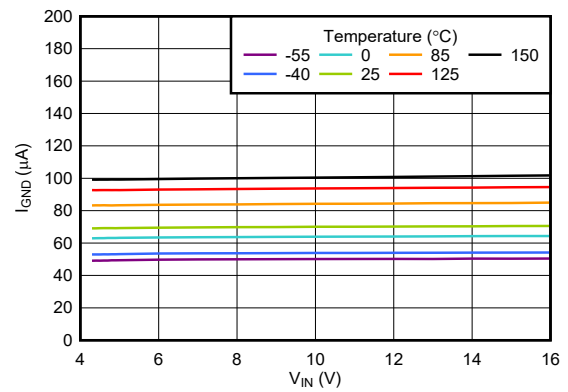


Figure 5-16. TPS76933-Q1 Ground Current vs Input Supply (New Chip)

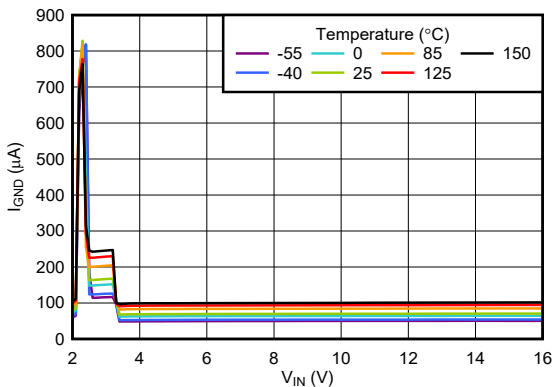


Figure 5-17. TPS76933-Q1 Ground Current vs Input Supply (New Chip)

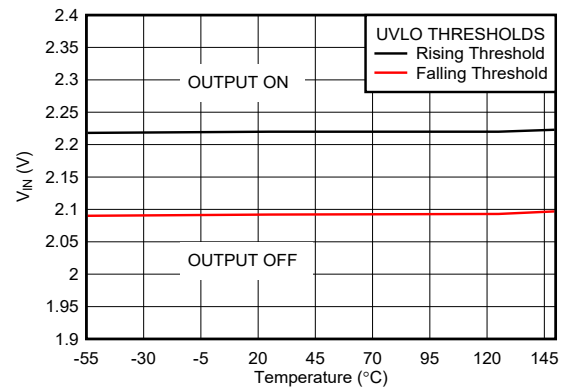


Figure 5-18. TPS76933-Q1 UVLO Threshold vs Free-Air Temperature (New Chip)

### 5.7 Typical Characteristics (continued)

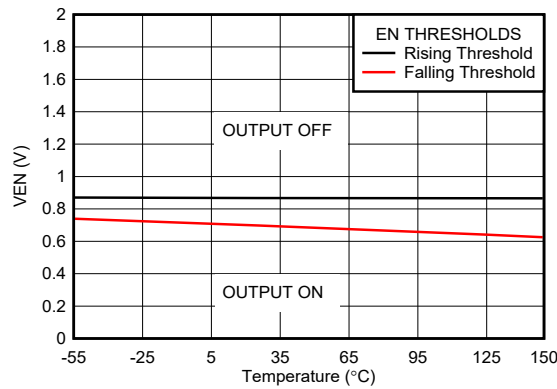


Figure 5-19. TPS76933-Q1 EN Threshold vs Free-Air Temperature (New Chip)

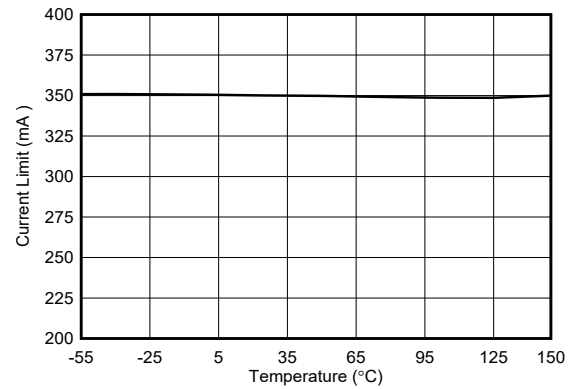


Figure 5-20. TPS76933-Q1 Current Limit vs Free-Air Temperature (New Chip)

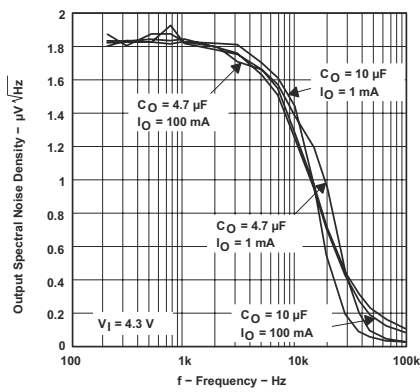


Figure 5-21. TPS76933-Q1 Output Spectral Noise Density vs Frequency (Legacy Chip)

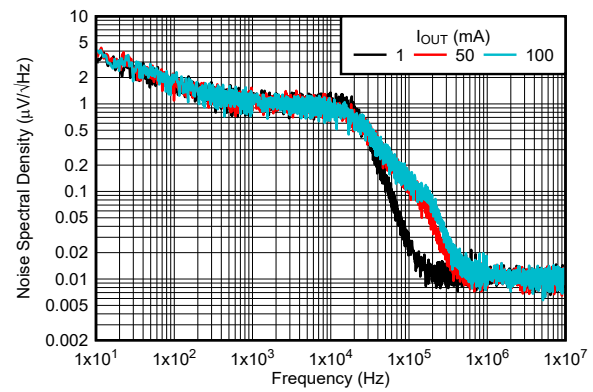


Figure 5-22. TPS76933-Q1 Output Spectral Noise Density vs Output Current (New Chip)

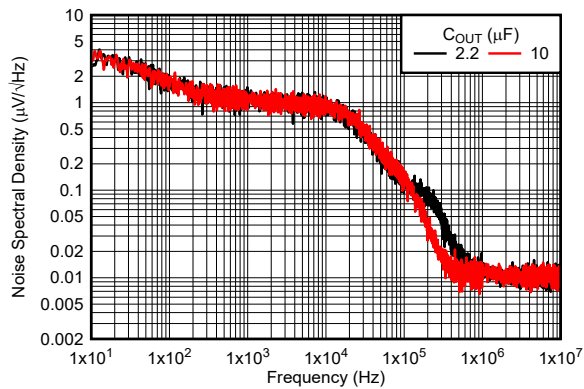


Figure 5-23. TPS76933-Q1 Output Spectral Noise Density vs Output Capacitor (New Chip)

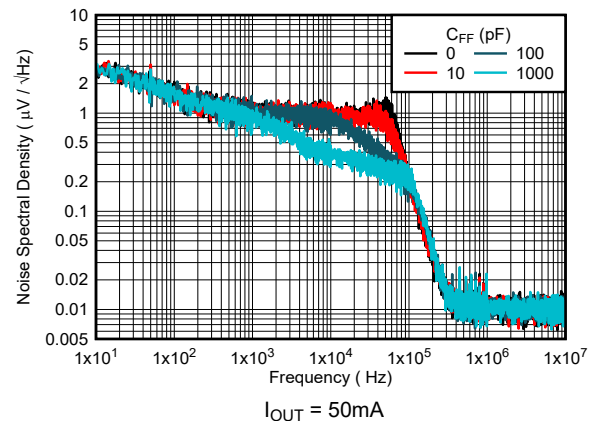


Figure 5-24. TPS76901-Q1 Output Spectral Noise Density vs Feed-Forward Capacitor (New Chip)

### 5.7 Typical Characteristics (continued)

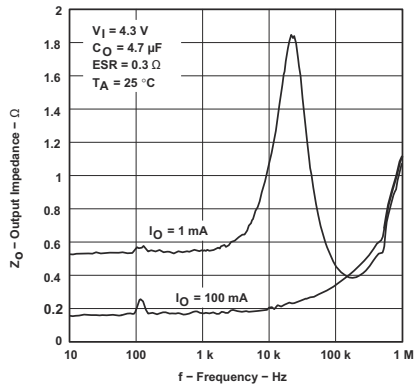


Figure 5-25. Output Impedance vs Frequency (Legacy Chip)

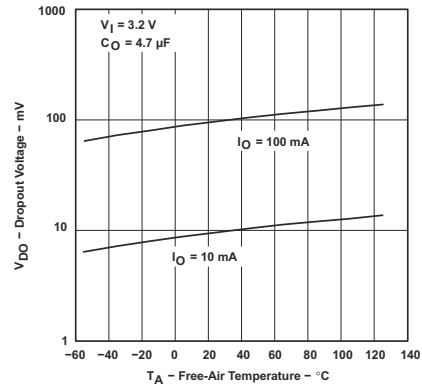


Figure 5-26. TPS76933-Q1 Dropout Voltage vs Free-Air Temperature (Legacy Chip)

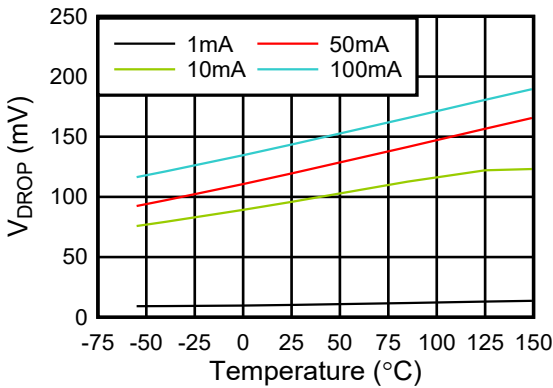


Figure 5-27. TPS76933-Q1 Dropout Voltage vs Free-Air Temperature (New Chip)

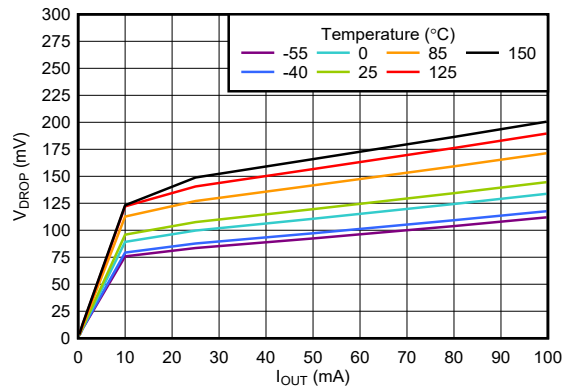


Figure 5-28. TPS76933-Q1 Dropout Voltage vs Output Current (New Chip)

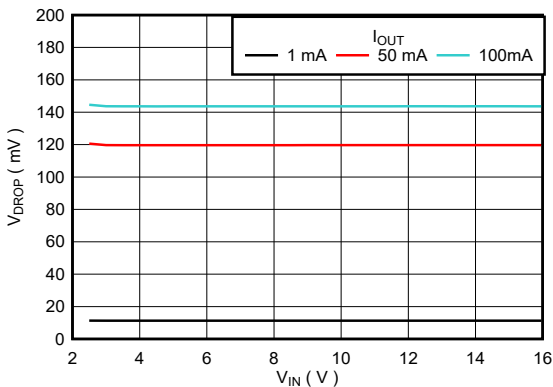


Figure 5-29. TPS76901-Q1 Dropout Voltage vs Input Supply (New Chip)

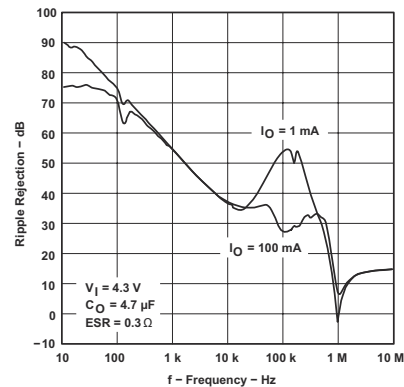


Figure 5-30. TPS76933-Q1 Ripple Rejection vs Frequency (Legacy Chip)

### 5.7 Typical Characteristics (continued)

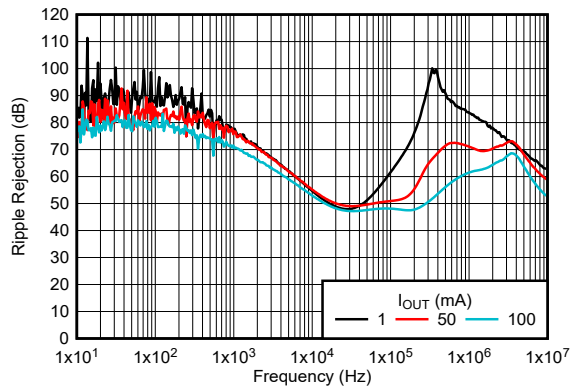


Figure 5-31. TPS76933-Q1 Ripple Rejection vs Output Current (New Chip)

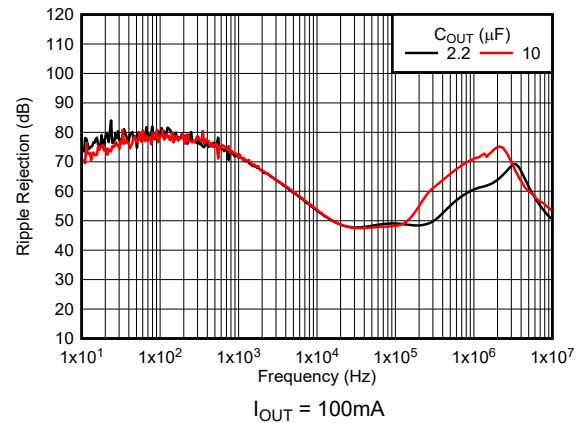


Figure 5-32. TPS76933-Q1 Ripple Rejection vs Output Capacitor (New Chip)

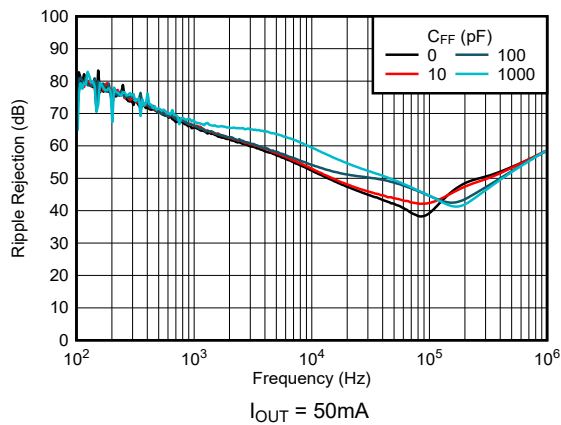


Figure 5-33. TPS76901-Q1 Ripple Rejection vs Feed-Forward Capacitor (New Chip)

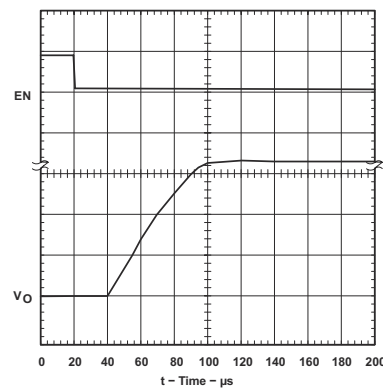


Figure 5-34. LDO Start-Up Time (Legacy Chip)

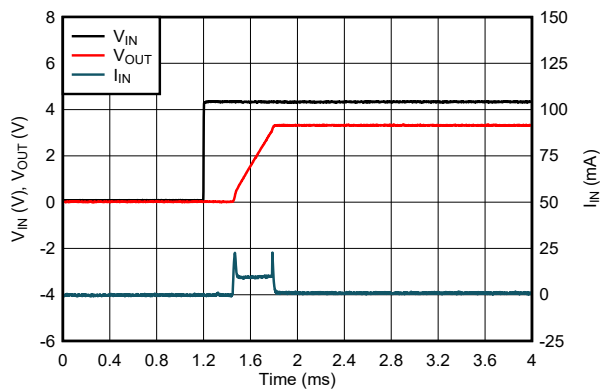


Figure 5-35. LDO Start-Up Time With Input Supply (New Chip)

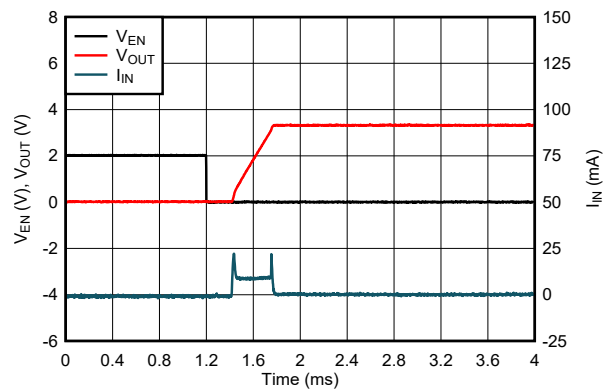


Figure 5-36. LDO Start-Up Time With EN (New Chip)

### 5.7 Typical Characteristics (continued)

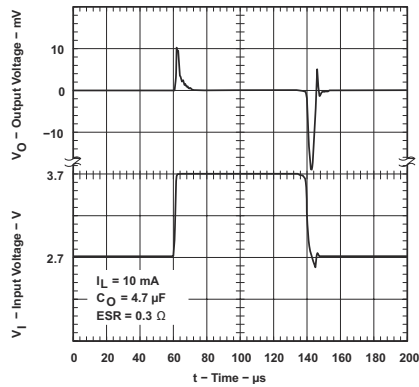


Figure 5-37. TPS76915-Q1 Line Transient Response (Legacy Chip)

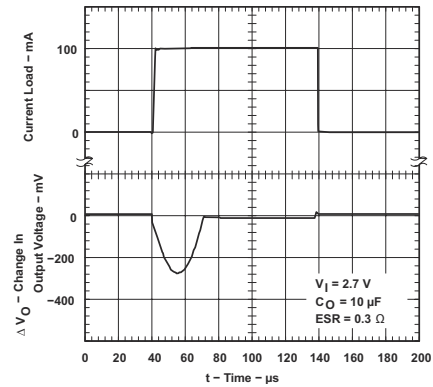


Figure 5-38. TPS76915-Q1 Load Transient Response (Legacy Chip)

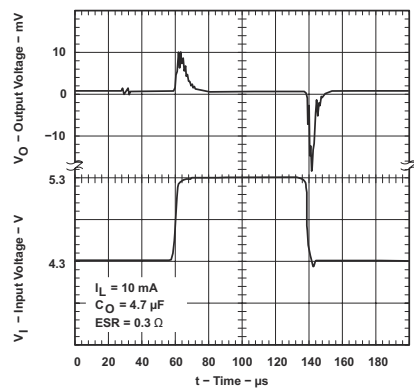
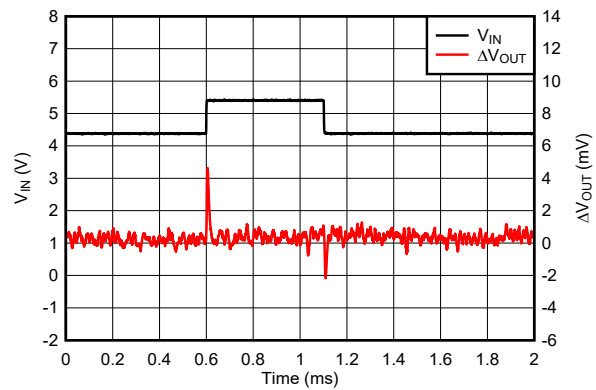
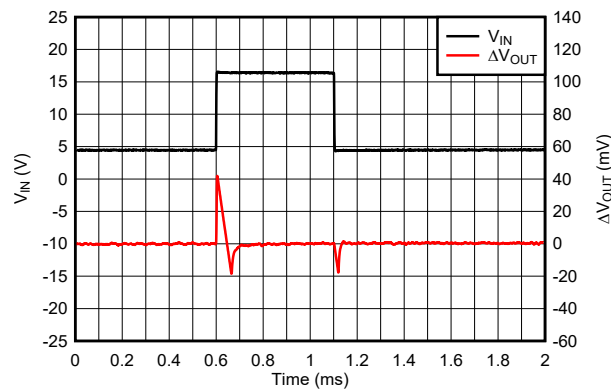


Figure 5-39. TPS76933-Q1 Line Transient Response (Legacy Chip)



4.3V to 5.3V at 1V/μs

Figure 5-40. TPS76933-Q1 Line Transient Response (New Chip)



4.3V to 16.0V at 1V/μs

Figure 5-41. TPS76933-Q1 Line Transient Response (New Chip)

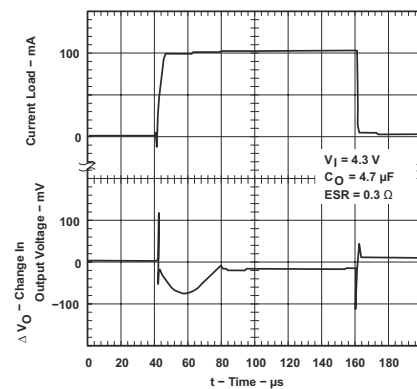


Figure 5-42. TPS76933-Q1 Load Transient Response (Legacy Chip)

### 5.7 Typical Characteristics (continued)

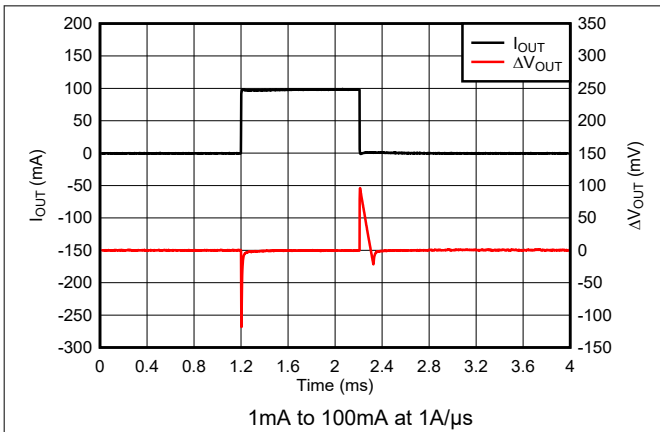


Figure 5-43. TPS76933-Q1 Load Transient Response (New Chip)

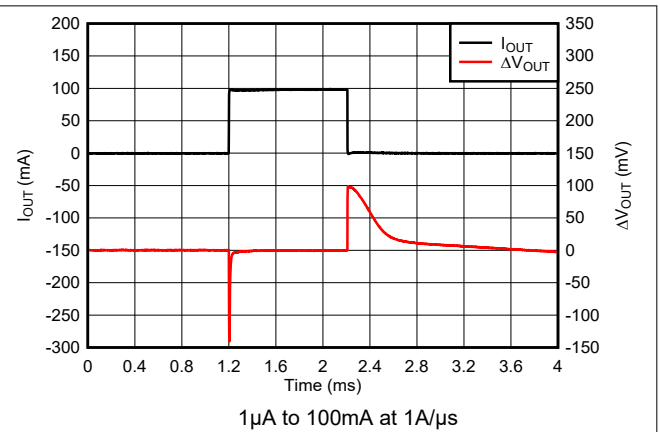


Figure 5-44. TPS76933-Q1 Load Transient Response (New Chip)

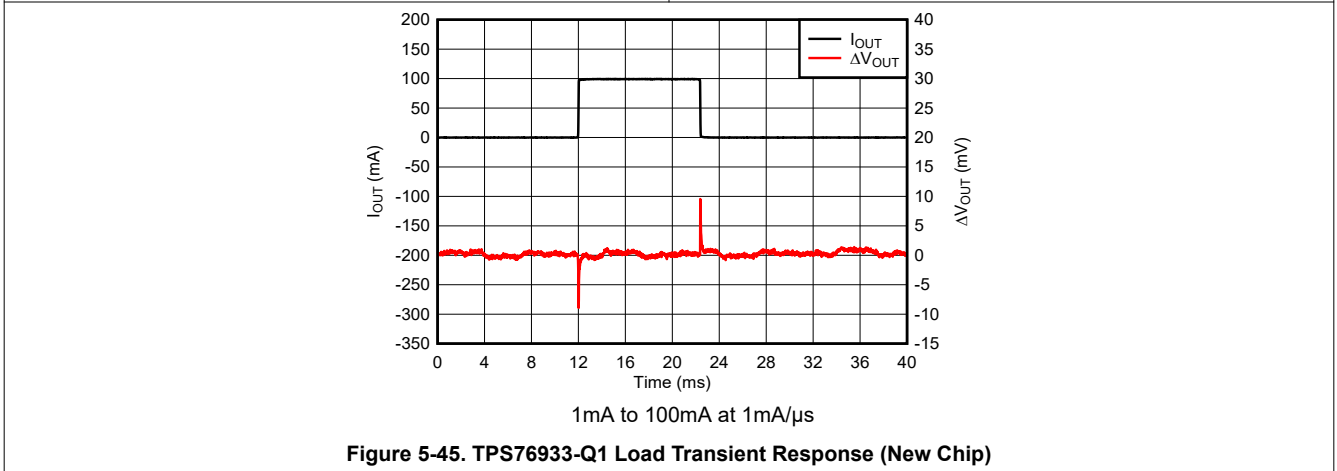


Figure 5-45. TPS76933-Q1 Load Transient Response (New Chip)

### 5.8 Typical Characteristics: Supported ESR Range

Equivalent series resistance (ESR) refers to the total series resistance. This resistance includes the ESR of the capacitor, any series resistance added externally, and PCB trace resistance to  $C_O$ .

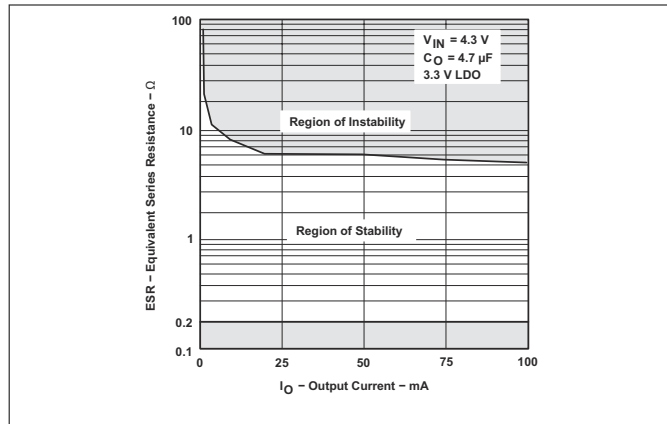


Figure 5-46. TPS76933-Q1 Typical Regions of Stability ESR vs Output Current (Legacy Chip)

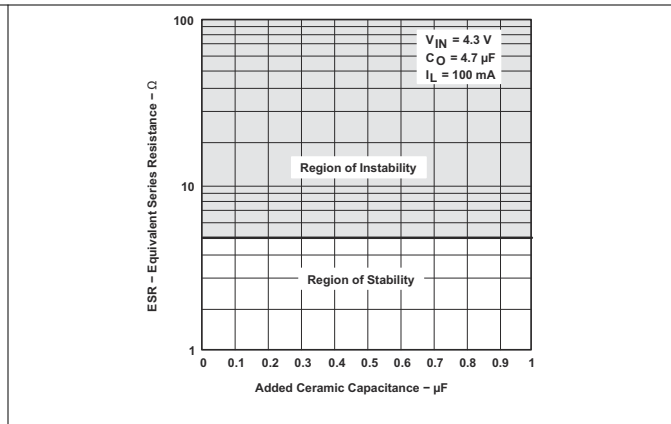


Figure 5-47. TPS76933-Q1 Typical Regions of Stability ESR vs Added Ceramic Capacitance (Legacy Chip)

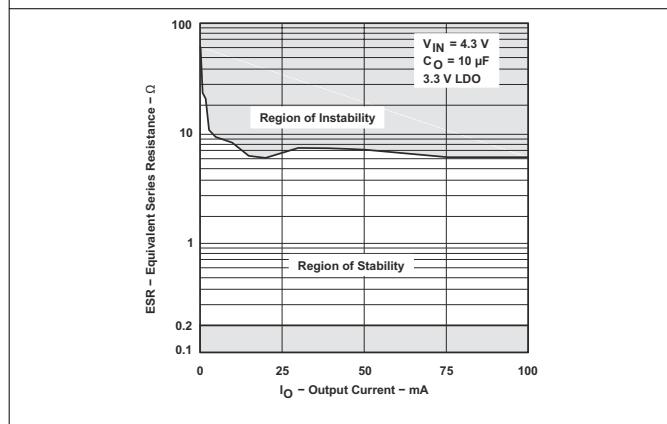


Figure 5-48. TPS76933-Q1 Typical Regions of Stability ESR vs Output Current (Legacy Chip)

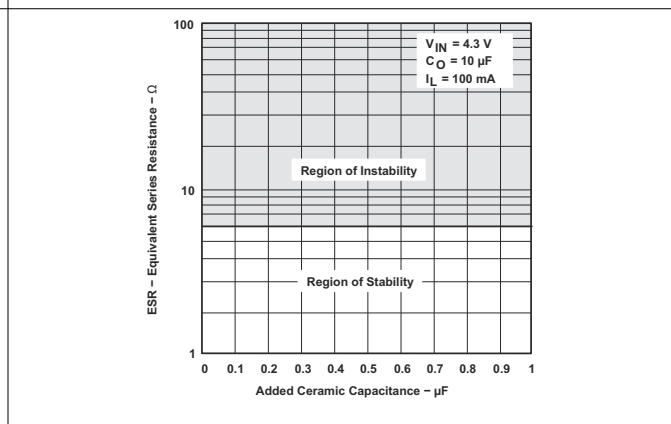


Figure 5-49. TPS76933-Q1 Typical Regions of Stability ESR vs Added Ceramic Capacitance (Legacy Chip)

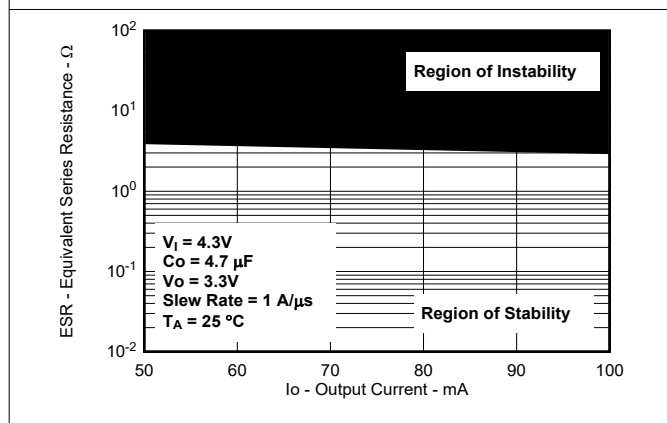


Figure 5-50. Typical Region of Stability ESR vs Output Current (New Chip)

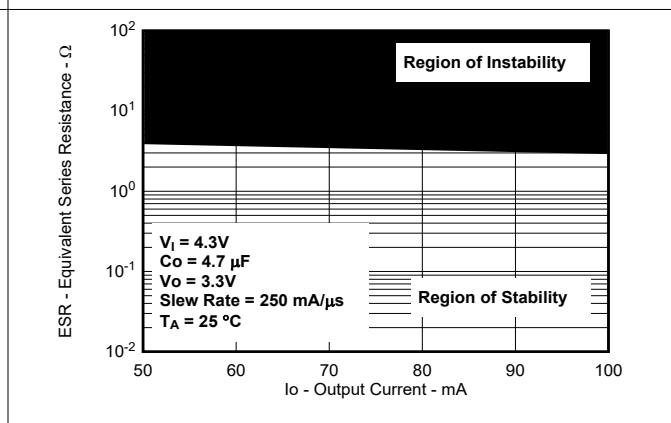


Figure 5-51. Typical Region of Stability ESR vs Output Current (New Chip)



### 5.8 Typical Characteristics: Supported ESR Range (continued)

Equivalent series resistance (ESR) refers to the total series resistance. This resistance includes the ESR of the capacitor, any series resistance added externally, and PCB trace resistance to  $C_O$ .

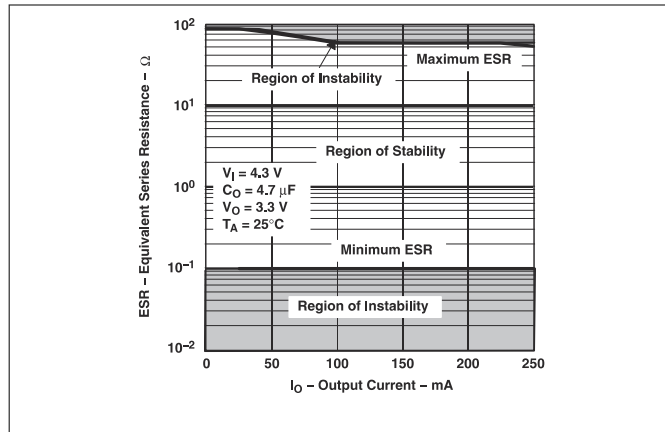


Figure 5-52. Typical Region of Stability ESR vs Output Current (Legacy Chip)

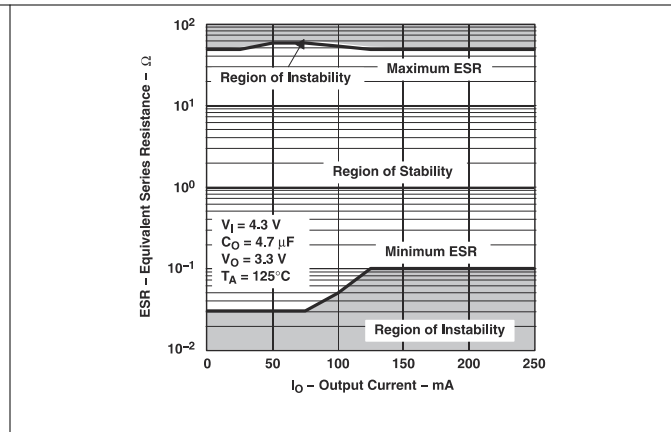


Figure 5-53. Typical Region of Stability ESR vs Output Current (Legacy Chip)

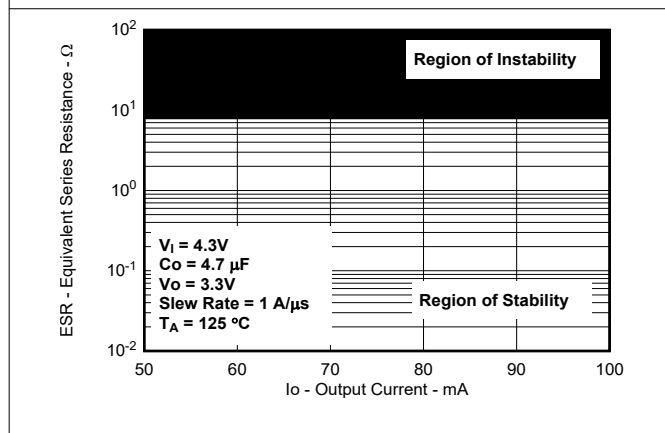


Figure 5-54. Typical Region of Stability ESR vs Output Current (New Chip)

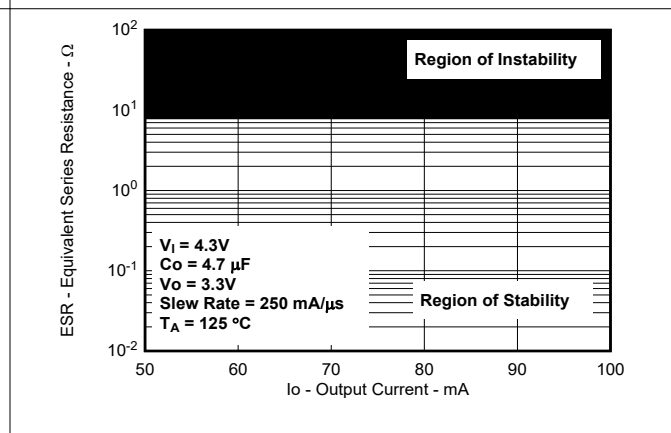


Figure 5-55. Typical Region of Stability ESR vs Output Current (New Chip)

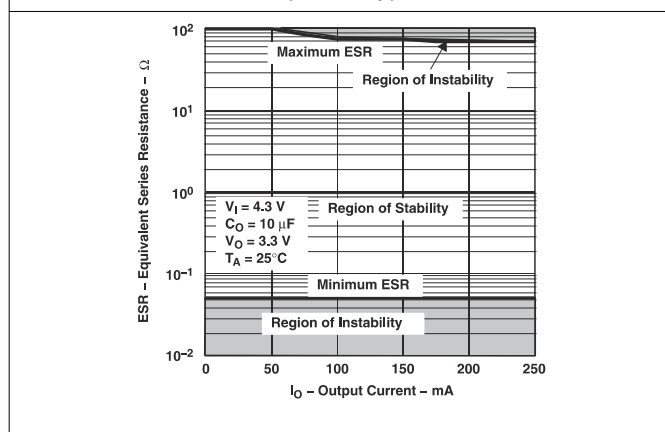


Figure 5-56. Typical Region of Stability ESR vs Output Current (Legacy Chip)

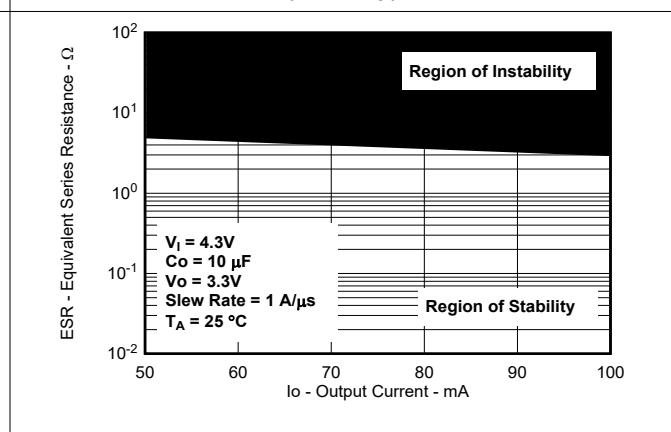


Figure 5-57. Typical Region of Stability ESR vs Output Current (New Chip)

### 5.8 Typical Characteristics: Supported ESR Range (continued)

Equivalent series resistance (ESR) refers to the total series resistance. This resistance includes the ESR of the capacitor, any series resistance added externally, and PCB trace resistance to  $C_O$ .

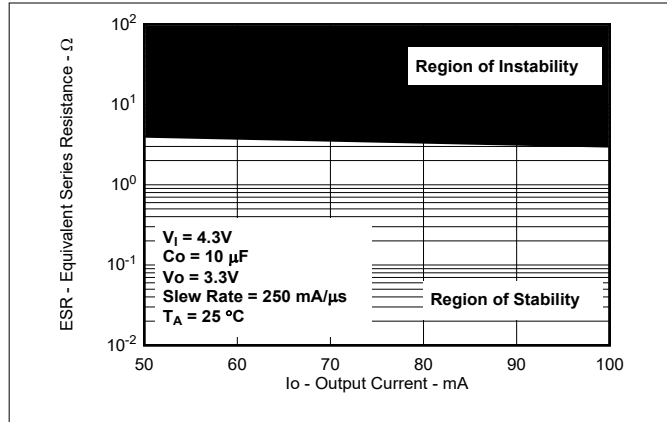


Figure 5-58. Typical Region of Stability ESR vs Output Current (New Chip)

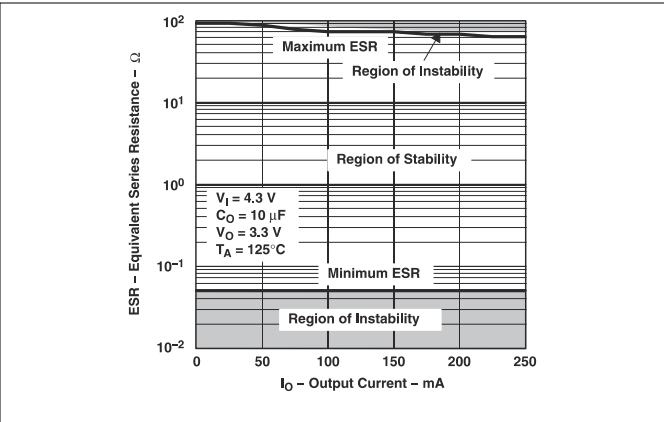


Figure 5-59. Typical Region of Stability ESR vs Output Current (Legacy Chip)

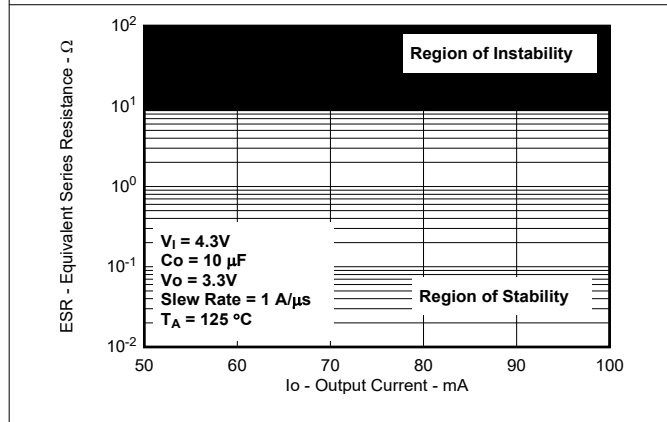


Figure 5-60. Typical Region of Stability ESR vs Output Current (New Chip)

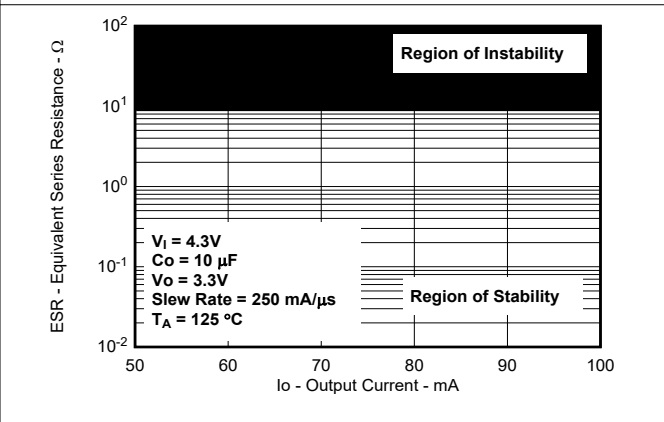


Figure 5-61. Typical Region of Stability ESR vs Output Current (New Chip)

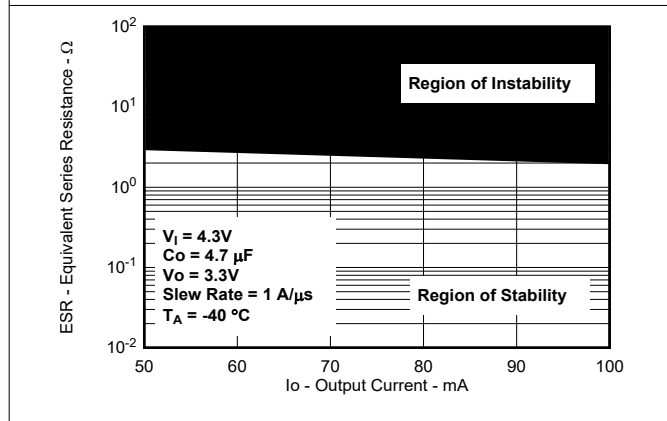


Figure 5-62. Typical Region of Stability ESR vs Output Current (New Chip)

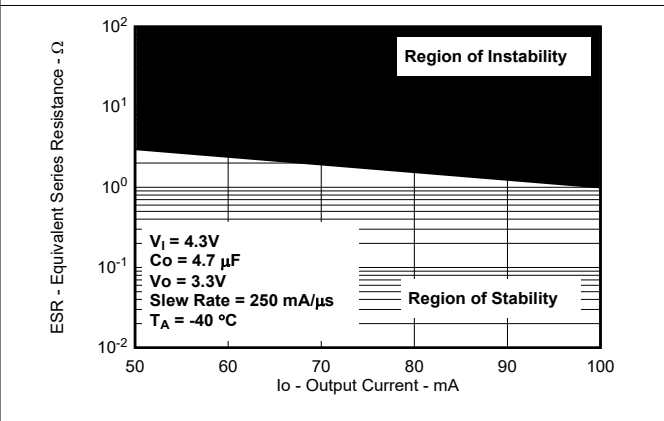
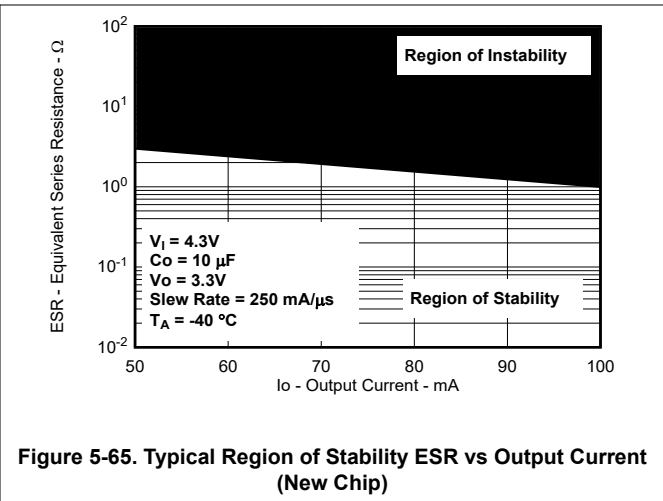
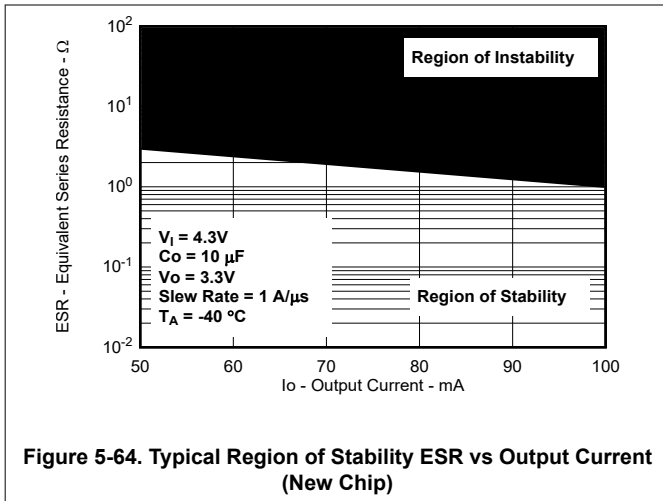


Figure 5-63. Typical Region of Stability ESR vs Output Current (Legacy Chip)

### 5.8 Typical Characteristics: Supported ESR Range (continued)

Equivalent series resistance (ESR) refers to the total series resistance. This resistance includes the ESR of the capacitor, any series resistance added externally, and PCB trace resistance to  $C_O$ .



## 6 Detailed Description

### 6.1 Overview

The TPS769-Q1 is a low quiescent current, high PSRR, low-dropout (LDO) voltage regulator capable of handling up to 100mA of the load current. The TPS769-Q1 is optimized for use in battery-powered and automotive applications.

The TPS769-Q1 features an integrated overcurrent limit, thermal shutdown, output enable, internal output pulldown, and undervoltage lockout (UVLO for the new chip). This device delivers excellent line and load transient performance and supports a wide range of ESR (up to 2Ω for the new chip). The operating ambient temperature range of the device is  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ .

### 6.2 Functional Block Diagrams

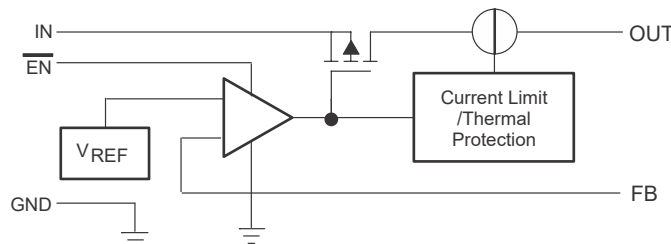


Figure 6-1. TPS76901-Q1 Functional Block Diagram (Legacy Chip)

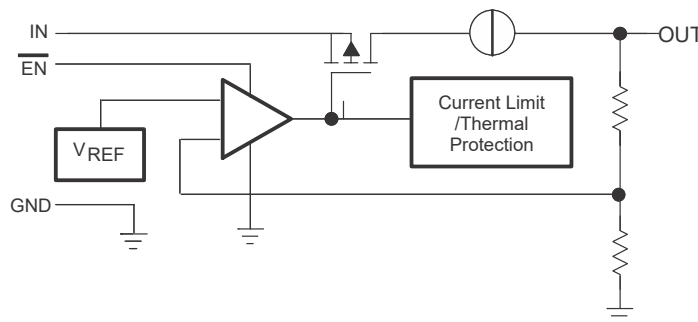


Figure 6-2. TPS769-Q1 Functional Block Diagram (Legacy Chip)

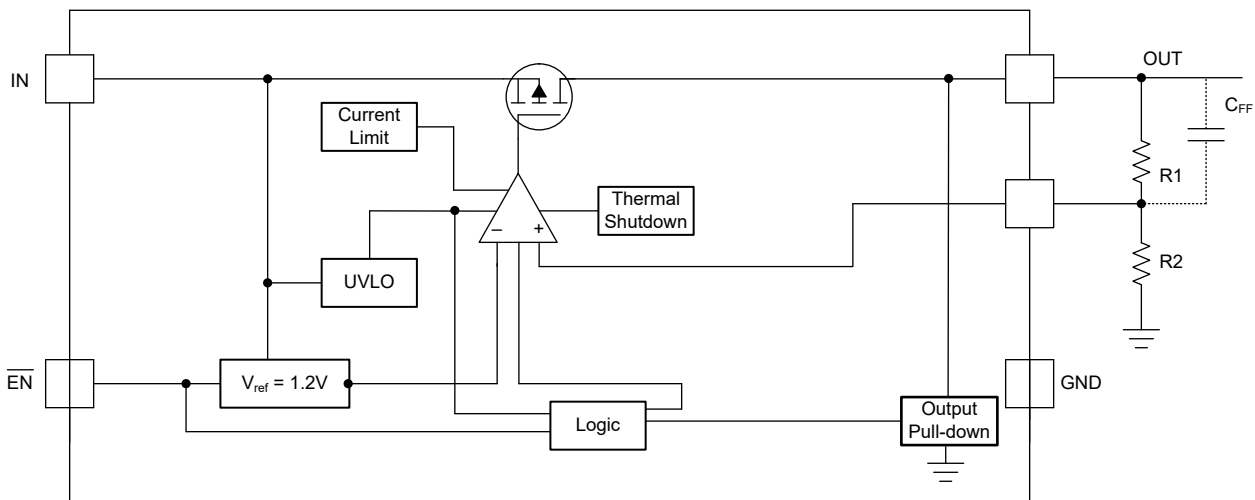
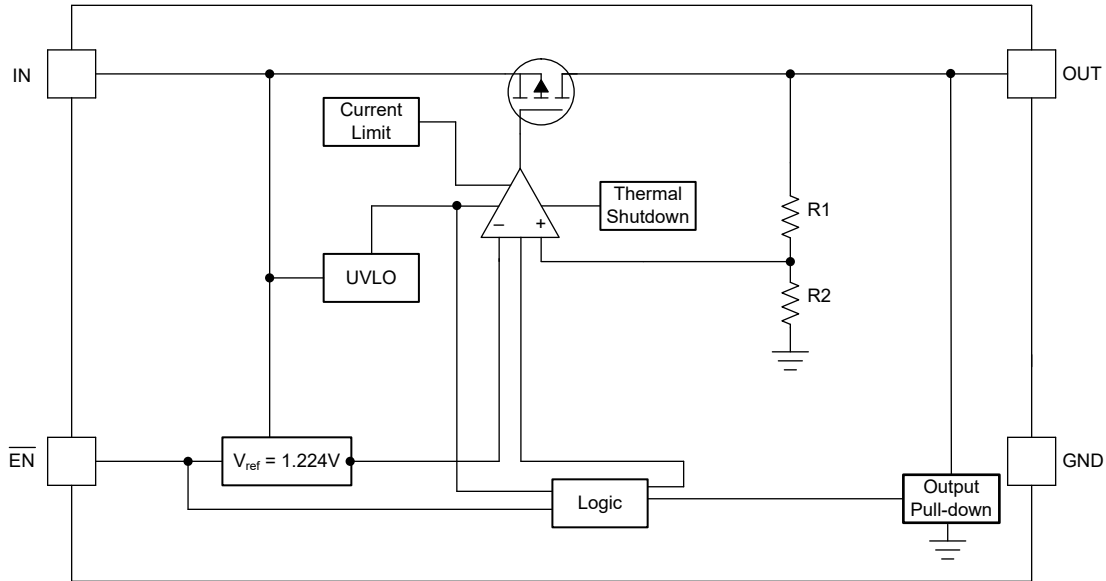


Figure 6-3. TPS76901-Q1 Functional Block Diagram (New Chip)



**Figure 6-4. TPS769-Q1 Functional Block Diagram (New Chip)**

## 6.3 Feature Description

### 6.3.1 Output Enable

The enable pin for the device is an active-low pin. The output voltage is enabled when the voltage of the enable pin is lower than the low-level input voltage of the  $\overline{\text{EN}}$  pin. The output voltage is disabled when the enable pin voltage is higher than the high-level input voltage of the  $\overline{\text{EN}}$  pin. If  $\overline{\text{EN}}$  functionality is not needed, connect the enable pin to the GND of the device.

For the new chip, there is an internal pullup current on the  $\overline{\text{EN}}$  pin. Therefore, leave the  $\overline{\text{EN}}$  pin floating. If the  $\overline{\text{EN}}$  pin is left floating, the LDO is disabled.

In the new chip, the device has an internal output pull-down circuit that activates when the device is disabled to actively discharge the output voltage. See the [Output Pull-down](#) section for further information.

### 6.3.2 Dropout Voltage

Dropout voltage ( $V_{\text{DO}}$ ) is defined as  $V_{\text{IN}} - V_{\text{OUT}}$  at the rated output current ( $I_{\text{RATED}}$ ), where the pass transistor is fully on.  $V_{\text{IN}}$  is the input voltage,  $V_{\text{OUT}}$  is the output voltage, and  $I_{\text{RATED}}$  is the maximum  $I_{\text{OUT}}$  listed in the [Recommended Operating Conditions](#) table. At this operating point, the pass transistor is driven fully on. Dropout voltage indirectly specifies a minimum input voltage greater than the nominal programmed output voltage where the output voltage is expected to stay in regulation. If the input voltage falls to less than the nominal output regulation, then the output voltage falls as well.

For a CMOS regulator, the dropout voltage is determined by the drain-source, on-state resistance ( $R_{\text{DS(ON)}}$ ) of the pass transistor. Therefore, if the linear regulator operates at less than the rated current, the dropout voltage for that current scales accordingly. The following equation calculates the  $R_{\text{DS(ON)}}$  of the device.

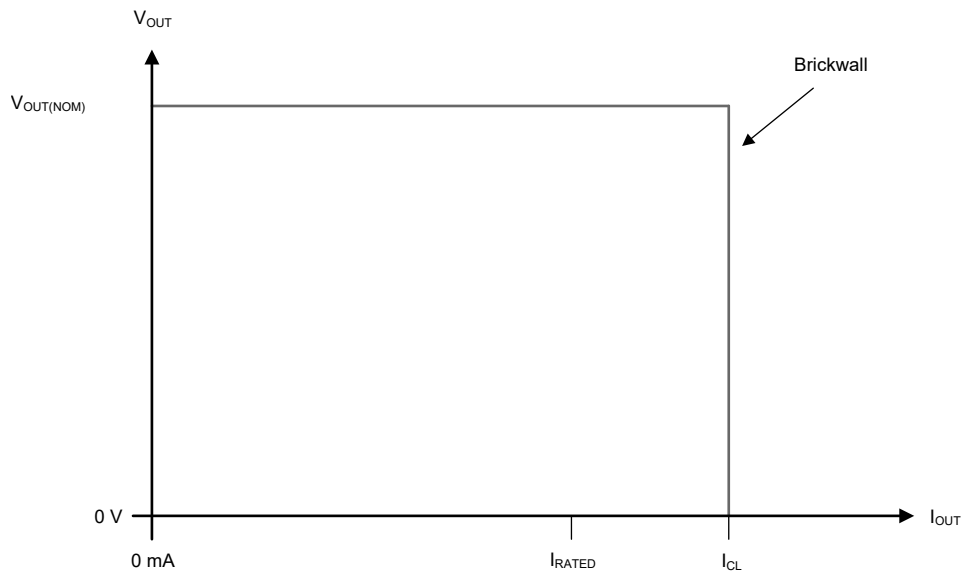
$$R_{\text{DS(ON)}} = \frac{V_{\text{DO}}}{I_{\text{RATED}}} \quad (1)$$

### 6.3.3 Current Limit

The device has an internal current limit circuit that protects the regulator during transient high-load current faults or shorting events. The current limit is a brick-wall scheme. In a high-load current fault, the brick-wall scheme limits the output current to the current limit ( $I_{\text{CL}}$ ).  $I_{\text{CL}}$  is listed in the [Electrical Characteristics](#) table.

The output voltage is not regulated when the device is in current limit. When a current limit event occurs, the device begins to heat up because of the increase in power dissipation. When the device is in brick-wall current limit, the pass transistor dissipates power  $[(V_{IN} - V_{OUT}) \times I_{CL}]$ . For more information on current limits, see the [Know Your Limits application note](#).

Figure 6-5 shows a diagram of the current limit.



**Figure 6-5. Current Limit**

### 6.3.4 Undervoltage Lockout (UVLO)

The device has an independent undervoltage lockout (UVLO) circuit that monitors the input voltage. Thus, allowing a controlled and consistent turn on and off of the output voltage. The UVLO circuit has hysteresis functionality to prevent the device from turning off if the input drops during turn on.

### 6.3.5 Output Pulldown

The device (new chip) has an output pulldown circuit. The output pulldown circuit activates under the following conditions:

- The device is disabled with  $\overline{\text{EN}}$  logic
- $1.0\text{V} < V_{\text{IN}} < V_{\text{UVLO}}$

The output pulldown resistance for this device is 1.5k $\Omega$  (typ), as listed in the [Electrical Characteristics](#) table.

Reverse current flows from the output to the input. Thus, do not rely on the output pulldown circuit for discharging a large amount of output capacitance after the input supply collapses. This reverse current flow potentially causes damage to the device. See the [Reverse Current](#) section for more details.

### 6.3.6 Thermal Shutdown

The device contains a thermal shutdown protection circuit to disable the device when the junction temperature ( $T_{\text{J}}$ ) of the pass transistor rises to  $T_{\text{SD(shutdown)}}$  (typical). Thermal shutdown hysteresis makes sure that the device resets (turns on) when the temperature falls to  $T_{\text{SD(reset)}}$  (typical).

The thermal time-constant of the semiconductor die is fairly short. Thus the device cycles on and off when thermal shutdown is reached until power dissipation is reduced. Power dissipation during start-up is high from large  $V_{\text{IN}} - V_{\text{OUT}}$  voltage drops across the device or from high inrush currents charging large output capacitors. Under some conditions, the thermal shutdown protection disables the device before start-up completes.

For reliable operation, limit the junction temperature to the maximum listed in the [Recommended Operating Conditions](#) table. Operation above this maximum temperature causes the device to exceed operational specifications. Although the device internal protection circuitry is designed to protect against thermal overload conditions, this circuitry is not intended to replace proper heat sinking. Continuously running the device into thermal shutdown or above the maximum recommended junction temperature reduces long-term reliability.

## 6.4 Device Functional Modes

[Table 6-1](#) shows the conditions that lead to the different modes of operation. See the [Electrical Characteristics](#) table for parameter values.

**Table 6-1. Device Functional Mode Comparison**

OPERATING MODE	PARAMETER			
	$V_{\text{IN}}$	$V_{\text{EN}}$	$I_{\text{OUT}}$	$T_{\text{J}}$
Normal operation	$V_{\text{IN}} > V_{\text{OUT(nom)}} + V_{\text{DO}}$ and $V_{\text{IN}} > V_{\text{IN(min)}}$	$V_{\text{EN}} < V_{\text{EN(LOW)}}$	$I_{\text{OUT}} < I_{\text{OUT(max)}}$	$T_{\text{J}} < T_{\text{SD(shutdown)}}$
Dropout operation	$V_{\text{IN(min)}} < V_{\text{IN}} < V_{\text{OUT(nom)}} + V_{\text{DO}}$	$V_{\text{EN}} < V_{\text{EN(LOW)}}$	$I_{\text{OUT}} < I_{\text{OUT(max)}}$	$T_{\text{J}} < T_{\text{SD(shutdown)}}$
Disabled (any true condition disables the device)	$V_{\text{IN}} < V_{\text{UVLO}}$	$V_{\text{EN}} > V_{\text{EN(HI)}}$	Not applicable	$T_{\text{J}} > T_{\text{SD(shutdown)}}$

#### 6.4.1 Normal Operation

The device regulates to the nominal output voltage when the following conditions are met:

- The input voltage is greater than the nominal output voltage plus the dropout voltage ( $V_{\text{OUT(nom)}} + V_{\text{DO}}$ ).
- The current sourced from OUT is less than the current limit ( $I_{\text{OUT}} < I_{\text{CL(OUT)}}$ ).
- The device junction temperature is less than the thermal shutdown temperature ( $T_{\text{J}} < T_{\text{SD}}$ ).
- The enable voltage has previously receded the enable low level threshold voltage and has not yet increased higher than the enable high level threshold. Or, the  $\overline{\text{EN}}$  pin is connected to ground.

#### 6.4.2 Dropout Operation

If the input voltage is lower than the nominal output voltage plus the specified dropout voltage, the device operates in dropout mode. In this mode, the output voltage tracks the input voltage. In this mode, the transient performance of the device becomes significantly degraded. During this mode, the pass transistor is driven fully on. Line or load transients in dropout potentially result in large output voltage deviations.

When the device is in a steady dropout state, the pass transistor is driven fully on. This state is defined as when the device is in dropout, directly after being in a normal regulation state, but *not* during start-up. Dropout occurs when  $V_{IN} < V_{OUT(NOM)} + V_{DO}$ . When the regulator exits dropout, the input voltage returns to a value  $\geq V_{OUT(NOM)} + V_{DO}$ . During this time, the output voltage potentially overshoots for a short period of time.  $V_{OUT(NOM)}$  is the nominal output voltage and  $V_{DO}$  is the dropout voltage. During dropout exit, the device pulls the pass transistor back from being driven fully on.

#### 6.4.3 Disabled

Shutdown the device output by forcing the enable pin voltage to less than the maximum EN pin low-level input voltage (see the [Electrical Characteristics](#) table). When disabled, the pass transistor turns off and internal circuits shut down. The output voltage is also actively discharged to ground by an internal discharge circuit from the output to ground.



## 7 Application and Implementation

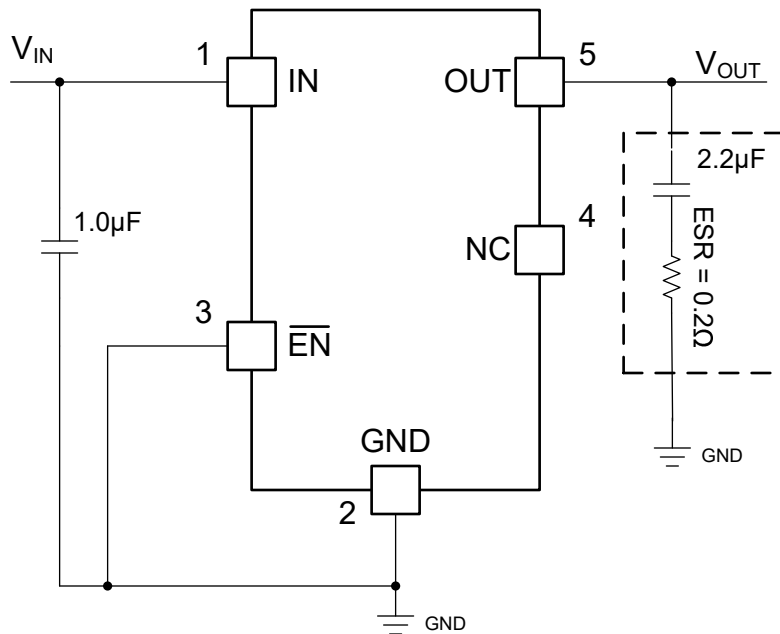
### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 7.1 Application Information

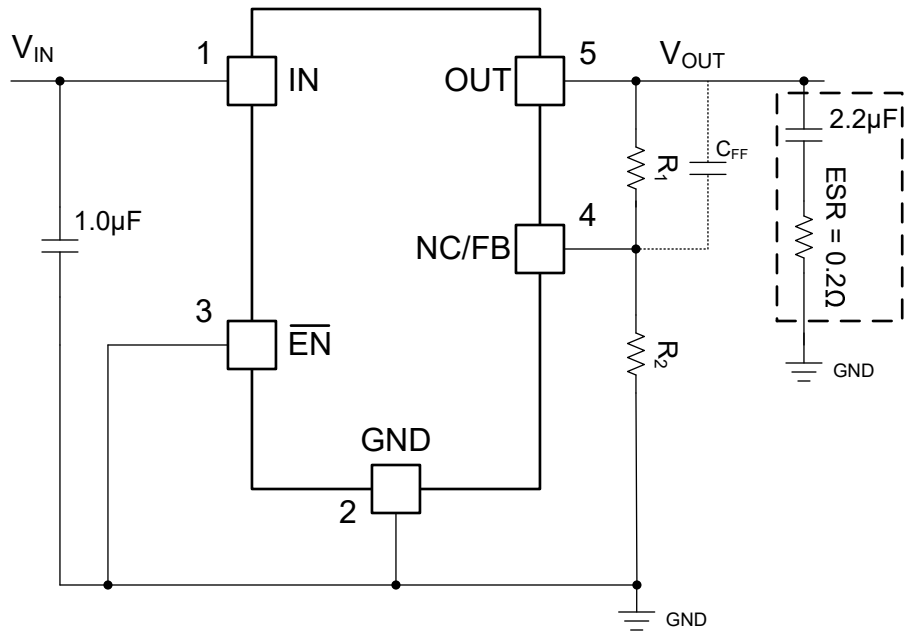
The TPS769-Q1 LDO provides a very accurate output with high PSRR and excellent line and load transient performance. The device is capable of handling up to 100mA of load current. Quiescent current consumption for the TPS769-Q1 is constant from no-load to maximum load. The TPS769-Q1 low dropout at a full 100mA load helps extend the battery operation range.

### 7.2 Typical Application



For fixed output voltage options only.

**Figure 7-1. Typical Application Circuit (Fixed-Voltage Option)**



For adjustable output voltage options only. Dotted lines indicate an optional  $C_{FF}$  capacitor (new chip). See the [Feed-Forward Capacitor \( \$C\_{FF}\$ \)](#) section.

**Figure 7-2. Typical Application Circuit (Adjustable-Voltage Option)**

Table 7-1 lists the  $R_1$  and  $R_2$  resistor values for the adjustable-voltage version.

**Table 7-1. Adjustable Output Voltage for Resistors  $R_1$  and  $R_2$**

OUTPUT VOLTAGE	$R_1$ (kΩ)	$R_2$ (kΩ)
2.5V	174	169
3.3V	287	169
3.6V	324	169
4.0V	383	169
5.0V	523	169

## 7.2.1 Design Requirements

Table 7-2 lists the design parameters for this example.

**Table 7-2. Design Parameters**

PARAMETER	EXAMPLE VALUE
Input voltage range	4V to 10V
Output voltage	2.5V to 5V
Output current rating	100mA
Output capacitor	4.7μF to 10μF
Output capacitor ESR range	200mΩ to 2Ω

## 7.2.2 Detailed Design Procedure

### 7.2.2.1 Adjustable Device Feedback Resistors

The adjustable-version device requires external feedback divider resistors to set the output voltage.  $V_{OUT}$  is set using the feedback divider resistors,  $R_1$  and  $R_2$ , according to the following equation:

$$V_{OUT} = V_{REF} \times (1 + R_1 / R_2) \quad (2)$$

where:

- $V_{REF} = 1.205V$  (typ) for the internal reference voltage (for the new chip)

To ignore the FB pin current error term in the  $V_{OUT}$  equation, set the feedback divider current to 100 times the FB pin current. This current is listed in the [Electrical Characteristics](#) table. This setting provides the maximum feedback divider series resistance, as shown in the following equation:

$$R_1 + R_2 \leq V_{OUT} / (I_{FB} \times 100) \quad (3)$$

In [Table 7-1](#), examples of  $R_1$  and  $R_2$  values are given for different output voltage options with a feedback divider current designed at 7μA.

### 7.2.2.2 Recommended Capacitor Types

The device (new chip) is designed to be stable using low equivalent series resistance (ESR) ceramic capacitors at the input and output. Multilayer ceramic capacitors have become the industry standard for these types of applications and are recommended, but use good judgment. Ceramic capacitors that employ X7R-, X5R-, and COG-rated dielectric materials provide relatively good capacitive stability across temperature. However, using Y5V-rated capacitors is discouraged because of large variations in capacitance.

Regardless of the ceramic capacitor type selected, the effective capacitance varies with operating voltage and temperature. Generally, expect the effective capacitance to decrease by as much as 50%. The input and output capacitors listed in the [Recommended Operating Conditions](#) table account for an effective capacitance of approximately 50% of the nominal value.

### 7.2.2.3 Input and Output Capacitor Requirements

Although an input capacitor is not required for stability, good analog design practice is to connect a capacitor from IN to GND. This capacitor counteracts reactive input sources and improves transient response, input ripple, and PSRR. Use an input capacitor if the source impedance is more than 0.5Ω. Use a higher value capacitor if large, fast rise-time, load, or line transients are anticipated. Additionally, use a higher-value capacitor if the device is located several inches from the input power source.

As with most low-dropout regulators, the TPS769-Q1 requires an output capacitor connected between OUT and GND to stabilize the internal control loop.

For the legacy chip, the device requires an output capacitor connected between OUT and GND to stabilize the internal control loop. The minimum recommended capacitance is 4.7μF. Make sure the equivalent series resistance (ESR) of the capacitor is between 0.2Ω and 10Ω to provide stability. Capacitor values larger than 4.7μF are acceptable, and allow the use of smaller ESR values. Capacitances less than 4.7μF are not

recommended because these components require careful selection of ESR to provide stability. Solid tantalum electrolytic, aluminum electrolytic, and multilayer ceramic capacitors are all suitable, provided these capacitors meet the described requirements. Most of the commercially available 4.7 $\mu$ F surface-mount solid tantalum capacitors, including devices from Sprague, Kemet, and Nichico, meet the ESR requirements previously stated. Multilayer ceramic capacitors potentially have very small equivalent series resistances and therefore require the addition of a low value series resistor to provide stability.

For the new chip, the device is designed to be stable using low ESR ceramic capacitors at the input and output. The minimum recommended capacitance value is 2.2 $\mu$ F and the ESR range is up to 2 $\Omega$ . The supported ESR range depends on the output capacitance, operating junction temperature, and load current conditions. The [Section 5.8](#) describes the supported ESR range in regards to the output capacitance across temperature for the supported load current range.

Dynamic performance of the device is improved by using an output capacitor. Use an output capacitor within the range specified in the [Recommended Operating Conditions](#) table for stability.

#### 7.2.2.4 Reverse Current

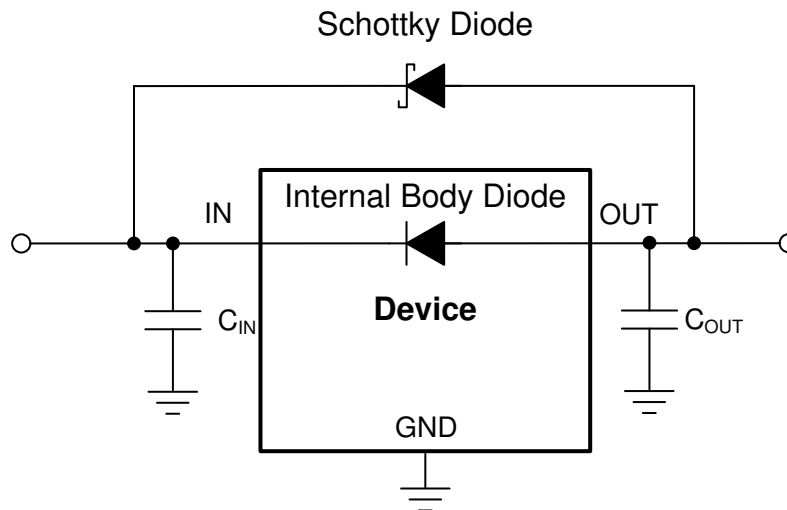
Excessive reverse current potentially damages this device. Reverse current flows through the intrinsic body diode of the pass transistor instead of the normal conducting channel. At high magnitudes, this current flow degrades the long-term reliability of the device.

Conditions where reverse current occur are outlined in this section, all of which potentially exceed the absolute maximum rating of  $V_{OUT} \leq V_{IN} + 0.3V$ .

- If the device has a large  $C_{OUT}$  and the input supply collapses with little or no load current
- The output is biased when the input supply is not established
- The output is biased above the input supply

If reverse current flow is expected in the application, use external protection to protect the device. Reverse current is not limited in the device, so use external limiting if extended reverse voltage operation is anticipated.

[Figure 7-3](#) shows one approach for protecting the device.



**Figure 7-3. Example Circuit for Reverse Current Protection Using a Schottky Diode**

#### 7.2.2.5 Feed-Forward Capacitor ( $C_{FF}$ )

For the adjustable-voltage version device, connect a feed-forward capacitor ( $C_{FF}$ ) from the OUT pin to the FB pin.  $C_{FF}$  improves transient, noise, and PSRR performance, but is not required for regulator stability. Recommended  $C_{FF}$  values are listed in the [Recommended Operating Conditions](#) table. If a higher capacitance  $C_{FF}$  is used, the start-up time increases. For a detailed description of  $C_{FF}$  tradeoffs, see the [Pros and Cons of Using a Feedforward Capacitor with a Low-Dropout Regulator application note](#).

$C_{FF}$  and  $R_1$  form a zero in the loop gain at frequency  $f_z$ .  $C_{FF}$ ,  $R_1$ , and  $R_2$  form a pole in the loop gain at frequency  $f_p$ . Calculate the  $C_{FF}$  zero and pole frequencies from the following equations:

$$f_z = 1 / (2 \times \pi \times C_{FF} \times R_1) \quad (4)$$

$$f_p = 1 / (2 \times \pi \times C_{FF} \times (R_1 \parallel R_2)) \quad (5)$$

$C_{FF} \geq 10\text{pF}$  is required for stability if the feedback divider current is less than  $5\mu\text{A}$ . The following equation calculates the feedback divider current.

$$I_{FB\_Divider} = V_{OUT} / (R_1 + R_2) \quad (6)$$

To avoid start-up time increases from  $C_{FF}$ , limit the product  $C_{FF} \times R_1$  to less than  $50\mu\text{s}$ .

For an output voltage of  $1.2\text{V}$  (for new chip) with the FB pin tied to the OUT pin, no  $C_{FF}$  is used.

#### 7.2.2.6 Power Dissipation ( $P_D$ )

Circuit reliability requires consideration of the device power dissipation, location of the circuit on the printed circuit board (PCB), and correct thermal plane sizing. Place few or no other heat-generating devices that cause added thermal stress in the PCB area around the regulator.

To first-order approximation, power dissipation in the regulator depends on the input-to-output voltage difference and load conditions. The following equation calculates power dissipation ( $P_D$ ).

$$P_D = (V_{IN} - V_{OUT}) \times I_{OUT} \quad (7)$$

---

#### Note

Minimize power dissipation, and therefore achieve greater efficiency, by correctly selecting the system voltage rails. For the lowest power dissipation use the minimum input voltage required for correct output regulation.

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For devices with a thermal pad, the primary heat conduction path for the device package is through the thermal pad to the PCB. Solder the thermal pad to a copper pad area under the device. This pad area contains an array of plated vias that conduct heat to additional copper planes for increased heat dissipation.

The maximum power dissipation determines the maximum allowable ambient temperature ( $T_A$ ) for the device. Power dissipation and junction temperature are most often related by the  $R_{\theta JA}$  of the combined PCB, device package, and the ambient air temperature ( $T_A$ ).  $R_{\theta JA}$  is the junction-to-ambient thermal resistance. The following equation calculates this relationship.

$$T_J = T_A + (R_{\theta JA} \times P_D) \quad (8)$$

Thermal resistance ( $R_{\theta JA}$ ) is highly dependent on the heat-spreading capability built into the particular PCB design.  $R_{\theta JA}$  therefore varies according to the total copper area, copper weight, and location of the planes. The junction-to-ambient thermal resistance listed in the [Thermal Information](#) table is determined by the JEDEC standard PCB and copper-spreading area.  $R_{\theta JA}$  is used as a relative measure of package thermal performance.  $R_{\theta JA}$  is improved by 35% to 55% compared to the [Thermal Information](#) table value by optimizing the PCB board layout. See the [An empirical analysis of the impact of board layout on LDO thermal performance application note](#) for further information.

#### 7.2.2.7 Estimating Junction Temperature

The JEDEC standard now recommends the use of psi ( $\Psi$ ) thermal metrics. These metrics estimate the junction temperatures of the linear regulator when in-circuit on a typical PCB board application. These metrics are not thermal resistance parameters and instead offer a practical and relative way to estimate junction temperature. These psi metrics are determined to be significantly independent of the copper area available for heat spreading. The [Thermal Information](#) table lists the primary thermal metrics, which are the junction-to-top characterization

parameter ( $\psi_{JT}$ ) and junction-to-board characterization parameter ( $\psi_{JB}$ ). These parameters provide two methods for calculating the junction temperature ( $T_J$ ), as described in the following equations. Use the junction-to-top characterization parameter ( $\psi_{JT}$ ) with the temperature at the center-top of device package ( $T_T$ ) to calculate the junction temperature. Use the junction-to-board characterization parameter ( $\psi_{JB}$ ) with the PCB surface temperature 1mm from the device package ( $T_B$ ) to calculate the junction temperature.

$$T_J = T_T + \psi_{JT} \times P_D \quad (9)$$

where:

- $P_D$  is the dissipated power
- $T_T$  is the temperature at the center-top of the device package

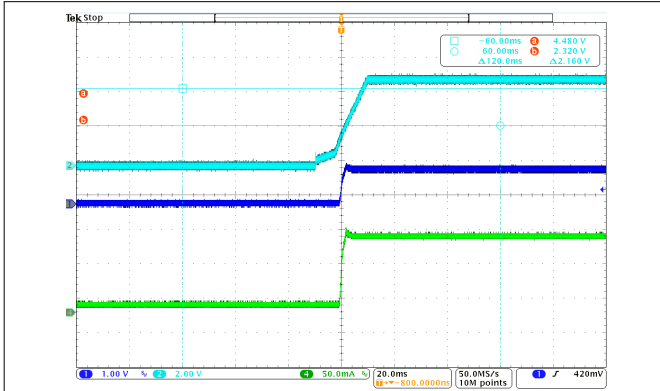
$$T_J = T_B + \psi_{JB} \times P_D \quad (10)$$

where:

- $T_B$  is the PCB surface temperature measured 1mm from the device package and centered on the package edge

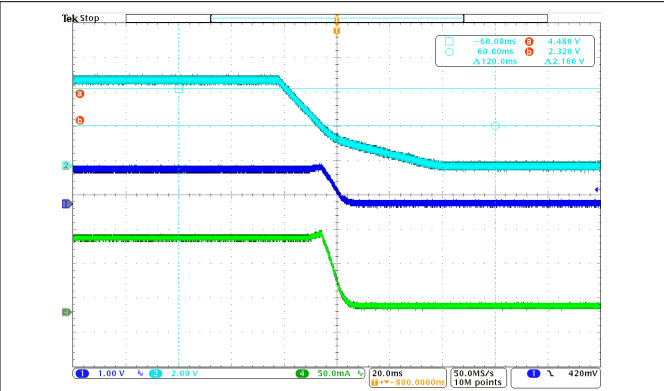
For detailed information on the thermal metrics and how to use them, see the [Semiconductor and IC Package Thermal Metrics application note](#).

### 7.2.3 Application Curves



Channel 1 =  $V_{OUT}$ , channel 2 =  $V_{IN}$ , channel 4 =  $I_{OUT}$

Figure 7-4. Power-Up Waveform (Legacy Chip)



Channel 1 =  $V_{OUT}$ , channel 2 =  $V_{IN}$ , channel 4 =  $I_{OUT}$

Figure 7-5. Power-Down Waveform (Legacy Chip)

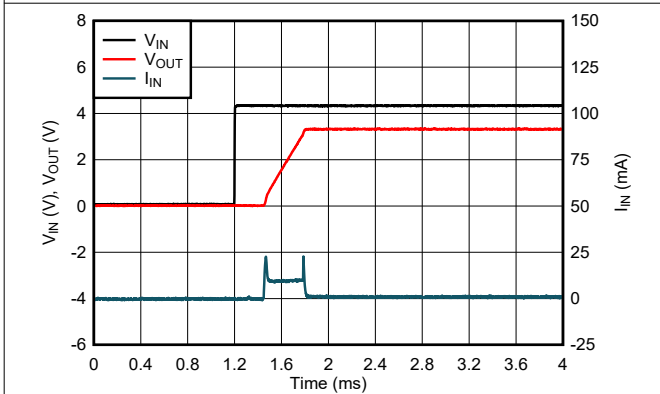


Figure 7-6. LDO Start-Up Time With Input supply (New Chip)

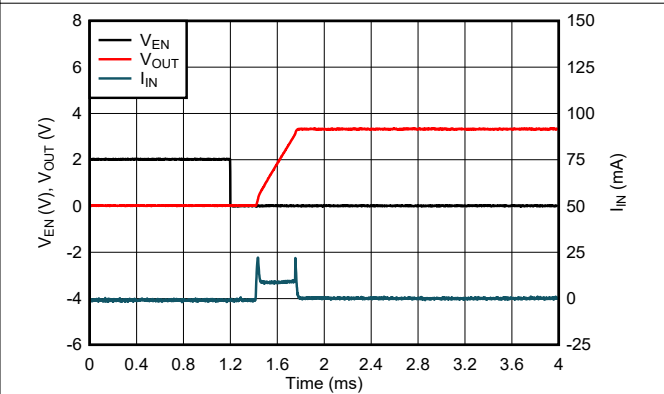


Figure 7-7. LDO Start-Up Time With EN (New Chip)

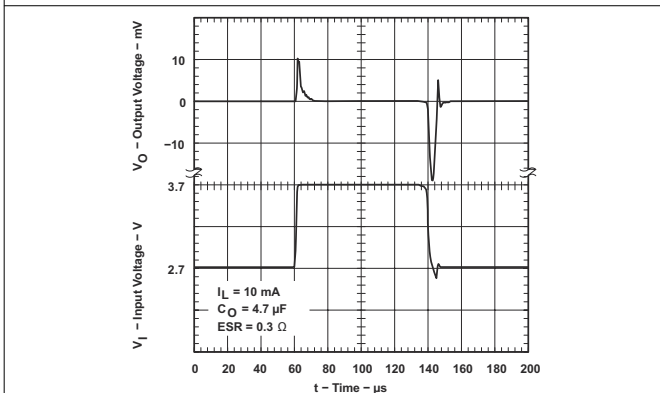


Figure 7-8. TPS76915-Q1 Line Transient Response (Legacy Chip)

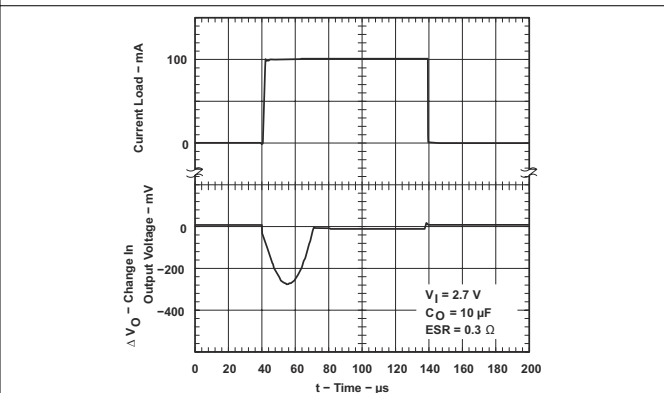
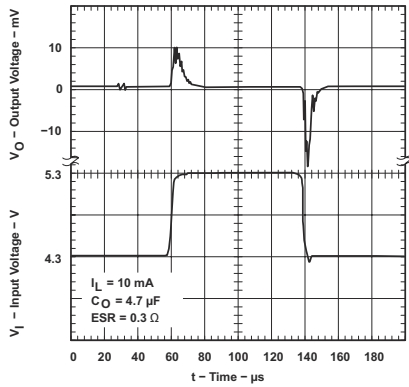
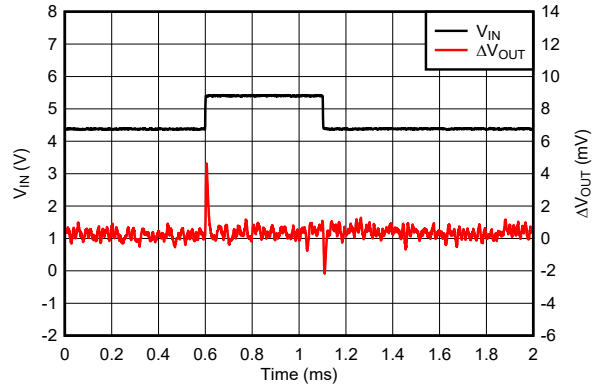


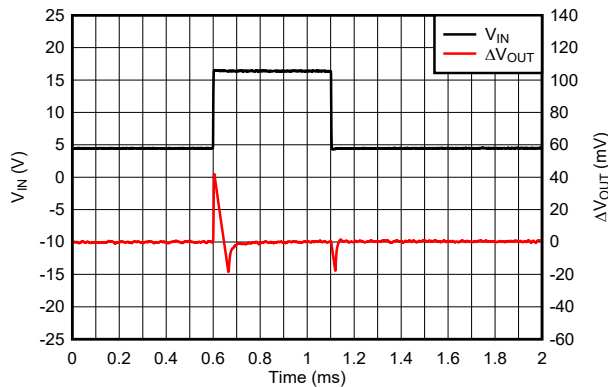
Figure 7-9. TPS76915-Q1 Load Transient Response (Legacy Chip)



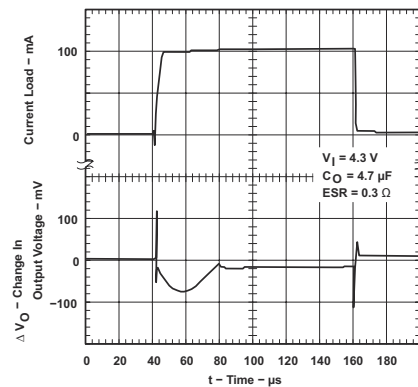
**Figure 7-10. TPS76933-Q1 Line Transient Response (Legacy Chip)**



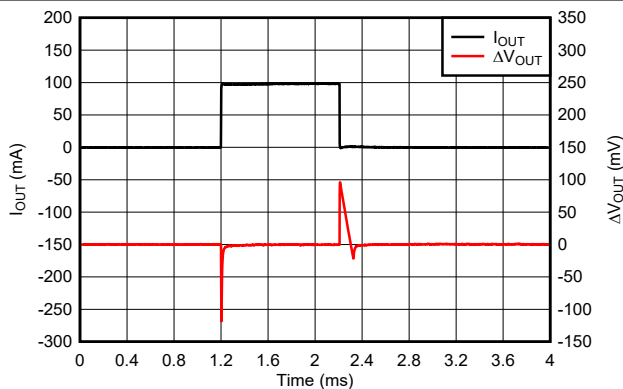
**Figure 7-11. TPS76933-Q1 Line Transient Response (New Chip)**



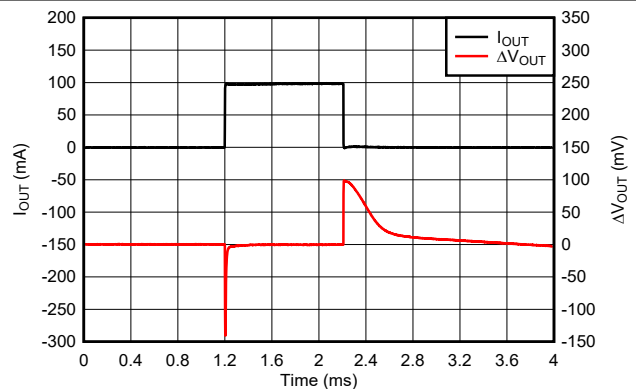
**Figure 7-12. TPS76933-Q1 Line Transient Response (New Chip)**



**Figure 7-13. TPS76933-Q1 Load Transient Response (Legacy Chip)**



**Figure 7-14. TPS76933-Q1 Load Transient Response (New Chip)**



**Figure 7-15. TPS76933-Q1 Load Transient Response (New Chip)**



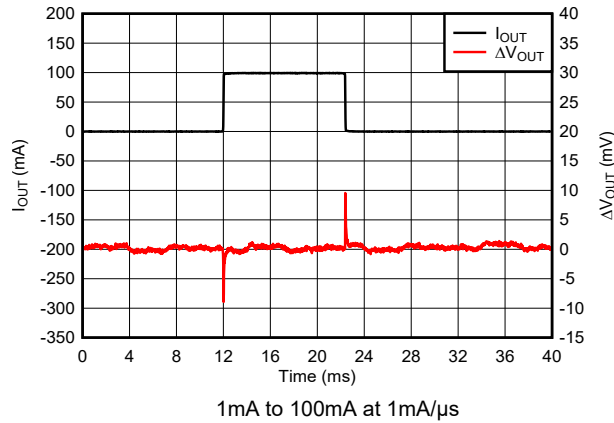


Figure 7-16. TPS76933-Q1 Load Transient Response (New Chip)

### 7.3 Power Supply Recommendations

The TPS769-Q1 is designed to operate from an input voltage supply range between 2.5V and 16V (new chip). The input voltage range provides adequate headroom for the device to have a regulated output. If the input supply is noisy, additional input capacitors with low ESR help improve the output noise performance.

### 7.4 Layout

#### 7.4.1 Layout Guidelines

For the LDO power supply, especially high voltage and large current supplies, layout is an important step. If layout is not carefully designed, the regulator potentially does not deliver enough output current because of thermal limitation. Spread the GND layer as large as possible and place enough thermal vias on the thermal pad. These steps help improve device thermal performance, and maximize the current output at high ambient temperature. [Figure 7-17](#) shows an example layout.

#### 7.4.2 Layout Example

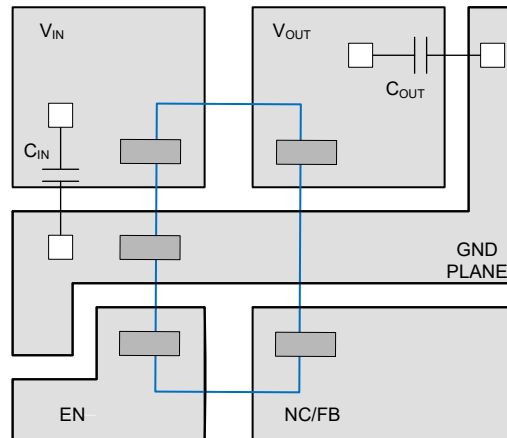


Figure 7-17. Layout Recommendation

## 8 Device and Documentation Support

### 8.1 Device Support

#### 8.1.1 Development Support

##### 8.1.1.1 Evaluation Module

An evaluation module (EVM) is available to assist in the initial circuit performance evaluation using the TPS769-Q1. Request the [TPS76901EVM-127 evaluation module](#) (and related [user's guide](#)) at the TI website through the product folders or purchase directly from [the TI eStore](#).

##### 8.1.1.2 Spice Models

Computer simulation of circuit performance using SPICE is often useful when analyzing the performance of analog circuits and systems. A SPICE model for the TPS769-Q1 is available through the product folders under *Tools & Software*.

##### 8.1.1.3 Device Nomenclature

**Table 8-1. Device Nomenclature**

PRODUCT <sup>(1)</sup>	V <sub>OUT</sub>
TPS769xxyyyz Legacy chip	xx is the nominal output voltage (for example, 28 = 2.8V, 285 = 2.85V, and 01 = Adjustable). yyy is the package designator. z is the package quantity.
TPS769xxyyyzM3 New chip	xx is the nominal output voltage (for example, 28 = 2.8V, 285 = 2.85V, and 01 = Adjustable). yyy is the package designator. z is the package quantity. M3 is a suffix designator for new chip redesigns on the latest TI process technology.

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI website at [www.ti.com](#).

### 8.2 Documentation Support

#### 8.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, [TPS709-Q1 150-mA, 30-V, 1-μA IQ Voltage Regulators With Enable data sheet](#)
- Texas Instruments, [Universal LDO Evaluation Module user guide](#)
- Texas Instruments, [Pros and Cons of Using a Feedforward Capacitor with a Low-Dropout Regulator application note](#)
- Texas Instruments, [Know Your Limits application note](#)

### 8.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](#). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 8.4 Support Resources

TI E2E™ [support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

### 8.5 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

## 8.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 8.7 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

<b>Changes from Revision D (September 2016) to Revision E (July 2024)</b>	<b>Page</b>
• Updated the numbering format for tables, figures, and cross-references throughout the document.....	1
• Changed entire document to align with current family format.....	1
• Added M3 devices to document.....	1

<b>Changes from Revision C (June 2012) to Revision D (September 2016)</b>	<b>Page</b>
• Added <i>ESD Ratings</i> table, <i>Thermal Information</i> table, <i>Feature Description</i> section, <i>Device Functional Modes, Application and Implementation</i> section, <i>Power Supply Recommendations</i> section, <i>Layout</i> section, <i>Device and Documentation Support</i> section, and <i>Mechanical, Packaging, and Orderable Information</i> section.....	1
• Removed <i>Ordering Information</i> table, see POA at the end of the data sheet.....	1

## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPS76901QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCFQ	<a href="#">Samples</a>
TPS76901QDBVRM3Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	PCFQ	<a href="#">Samples</a>
TPS76901QDBVRQ1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCFQ	<a href="#">Samples</a>
TPS76915QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCHQ	<a href="#">Samples</a>
TPS76918QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCIQ	<a href="#">Samples</a>
TPS76918QDBVRQ1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCIQ	<a href="#">Samples</a>
TPS76925QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCJQ	<a href="#">Samples</a>
TPS76925QDBVRQ1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCJQ	<a href="#">Samples</a>
TPS76927QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCKQ	<a href="#">Samples</a>
TPS76928QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCLQ	<a href="#">Samples</a>
TPS76930QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCMQ	<a href="#">Samples</a>
TPS76930QDBVRQ1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCMQ	<a href="#">Samples</a>
TPS76933QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCNQ	<a href="#">Samples</a>
TPS76933QDBVRM3Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	PCNQ	<a href="#">Samples</a>
TPS76933QDBVRQ1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCNQ	<a href="#">Samples</a>
TPS76950QDBVRG4Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCOQ	<a href="#">Samples</a>
TPS76950QDBVRM3Q1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	PCOQ	<a href="#">Samples</a>
TPS76950QDBVRQ1	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	PCOQ	<a href="#">Samples</a>

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of  $\leq 1000$ ppm threshold. Antimony trioxide based flame retardants must also meet the  $\leq 1000$ ppm threshold requirement.

<sup>(3)</sup> **MSL, Peak Temp.** - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> **Lead finish/Ball material** - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF TPS769-Q1 :

- Catalog : [TPS769](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

## TAPE AND REEL INFORMATION



### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS76901QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76901QDBVRQ1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76915QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76918QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76918QDBVRQ1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76925QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76925QDBVRQ1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76927QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76928QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76930QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76930QDBVRQ1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76933QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76933QDBVRQ1	SOT-23	DBV	5	3000	180.0	9.0	3.15	3.2	1.4	4.0	8.0	Q3
TPS76950QDBVRG4Q1	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
TPS76950QDBVRQ1	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS76901QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76901QDBVRQ1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76915QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76918QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76918QDBVRQ1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76925QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76925QDBVRQ1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76927QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76928QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76930QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76930QDBVRQ1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76933QDBVRG4Q1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76933QDBVRQ1	SOT-23	DBV	5	3000	182.0	182.0	20.0
TPS76950QDBVRG4Q1	SOT-23	DBV	5	3000	180.0	180.0	18.0
TPS76950QDBVRQ1	SOT-23	DBV	5	3000	180.0	180.0	18.0





# EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:15X



SOLDER MASK DETAILS

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NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:15X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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